



3D silicon sensors as timing detectors

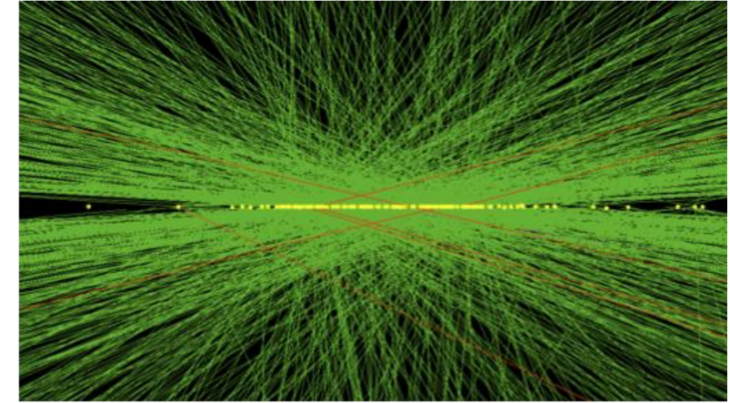
Leena Diehl, Jochen Dingfelder, Oscar Ferrer, Marc Hauser, Fabian Huegging, Karl Jakobs, Hans Krueger, Fabian Lex, Gregor Kramberger, Ulrich Parzefall, Giulio Pellegrini, Dennis Sperlich, Iveta Zatocilova

18.06.2024

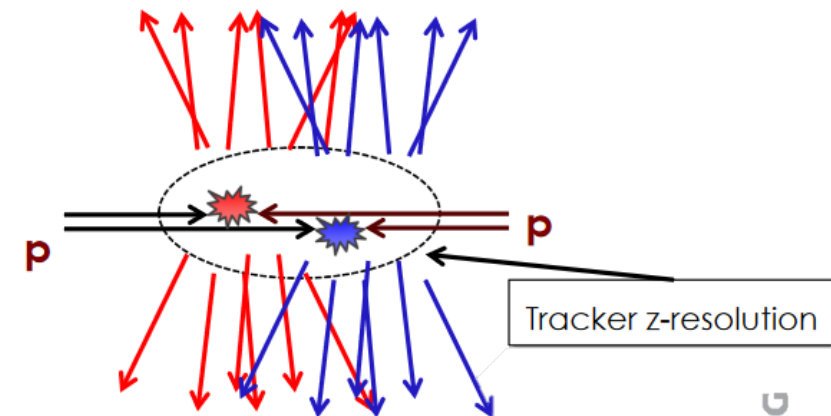


Introduction

- Future hadron colliders challenge the tracking and reconstruction with high rates and huge pile-up
- ATLAS and CMS already aim for 30-40ps timing resolution, future trackers like FCC will demand timing of 5ps while still providing position resolution below 10 μm in high density environments
- Many collaborations working on improving time resolution, e.g.
 - ➔ Ultra Fast Silicon Detectors (UFSDs - LGADs)
 - Working on improving radiation hardness (gain layer degradation)
 - ➔ 3D pixel sensors dedicated for timing: RD50 project
 - Potential alternative: proven radiation hardness, gain increase
- This study will focus on fast 3D of an earlier generation and the new dedicated timing sensors from the RD50 project

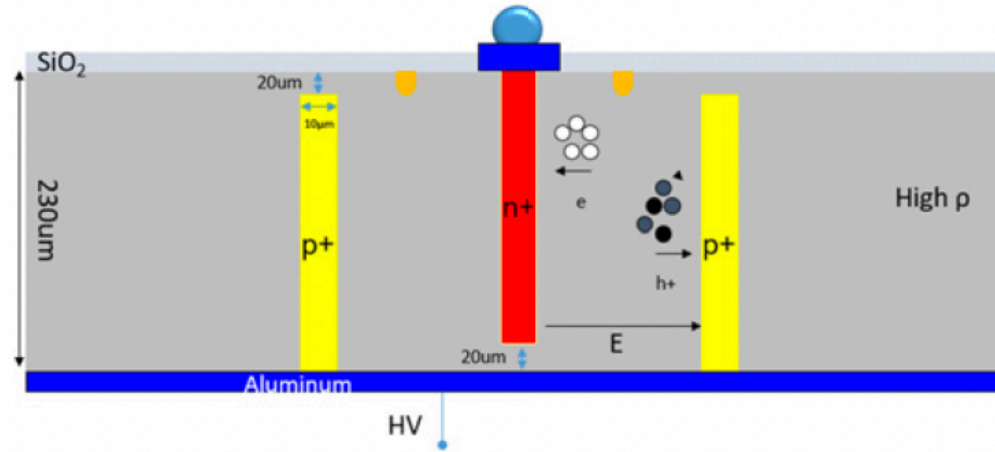


Tracking z-resolution larger than vertex-separation: Ambiguous Track-to-vertex association

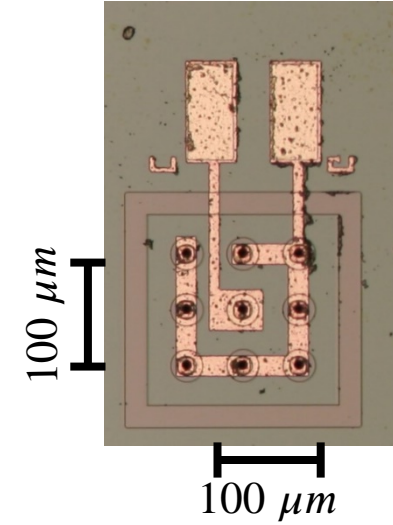


N. Cartiglia, INFN, Hiroshima Conference 2017

3D sensors



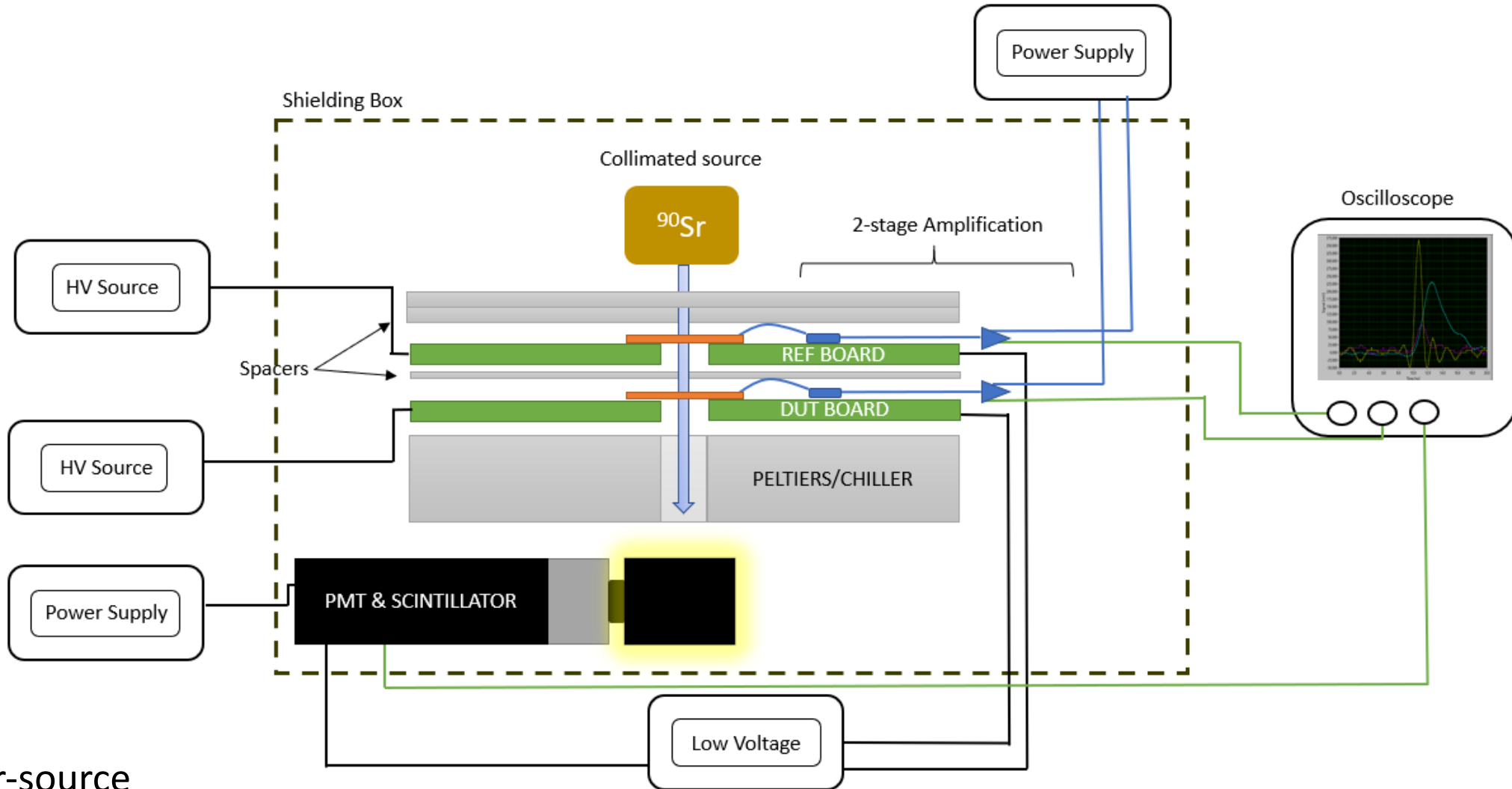
(a) IBL schematics



Insertable B-Layer production

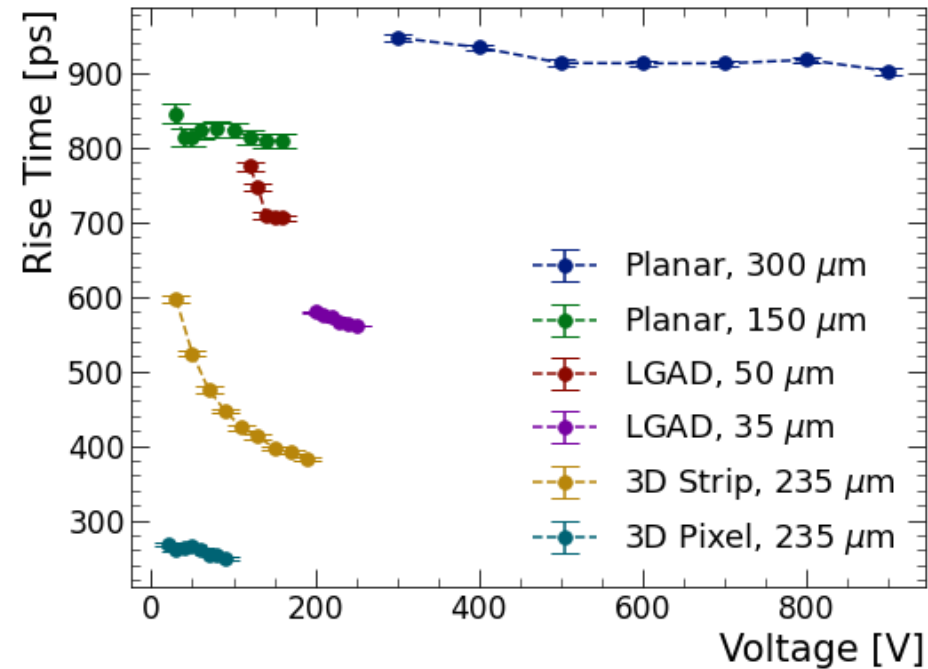
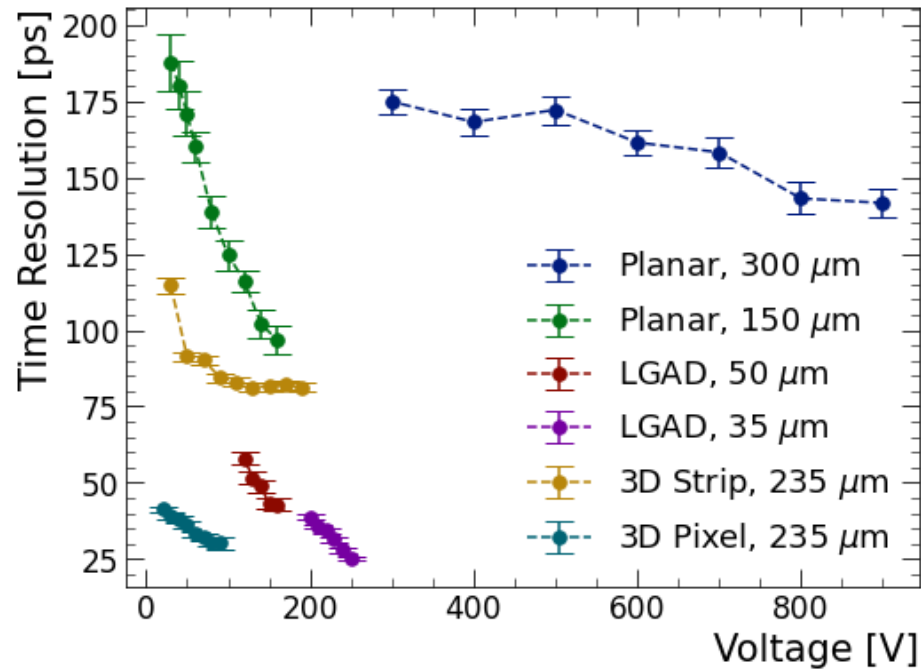
- Double-sided
- 235 μm active thickness
- 50 \times 50 μm^2 unit cell size
- 100 \times 100 μm^2 active area
- Depletion voltage: 5-10 V

Experimental Setup



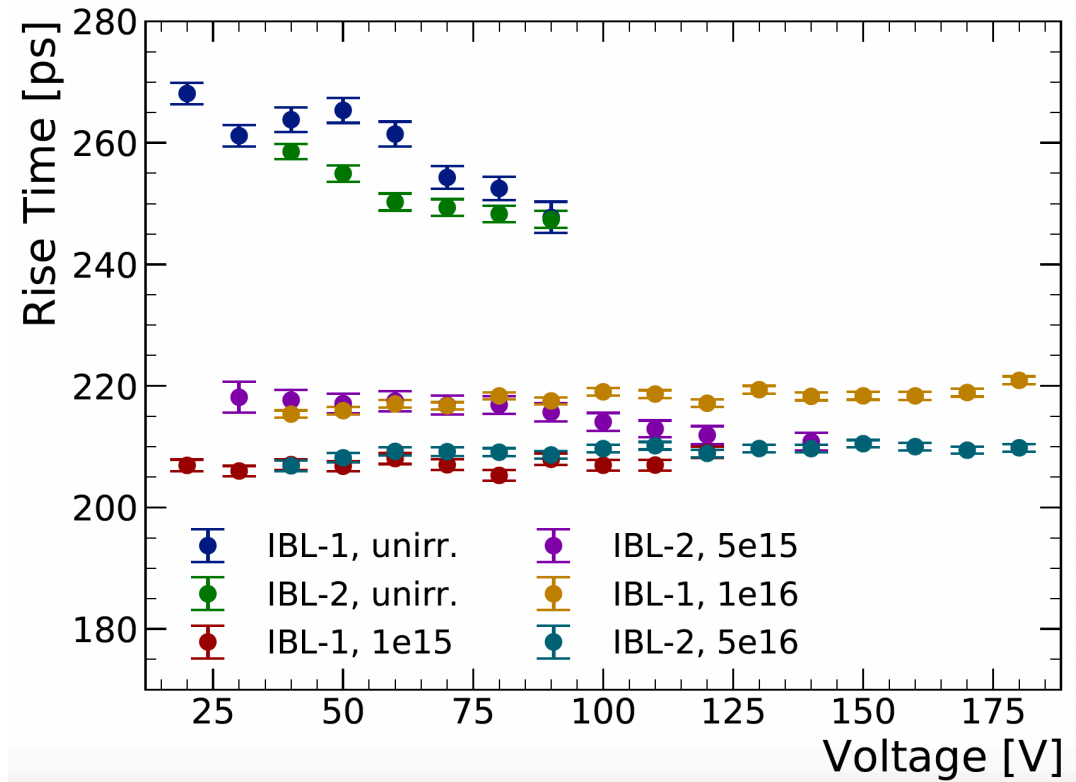
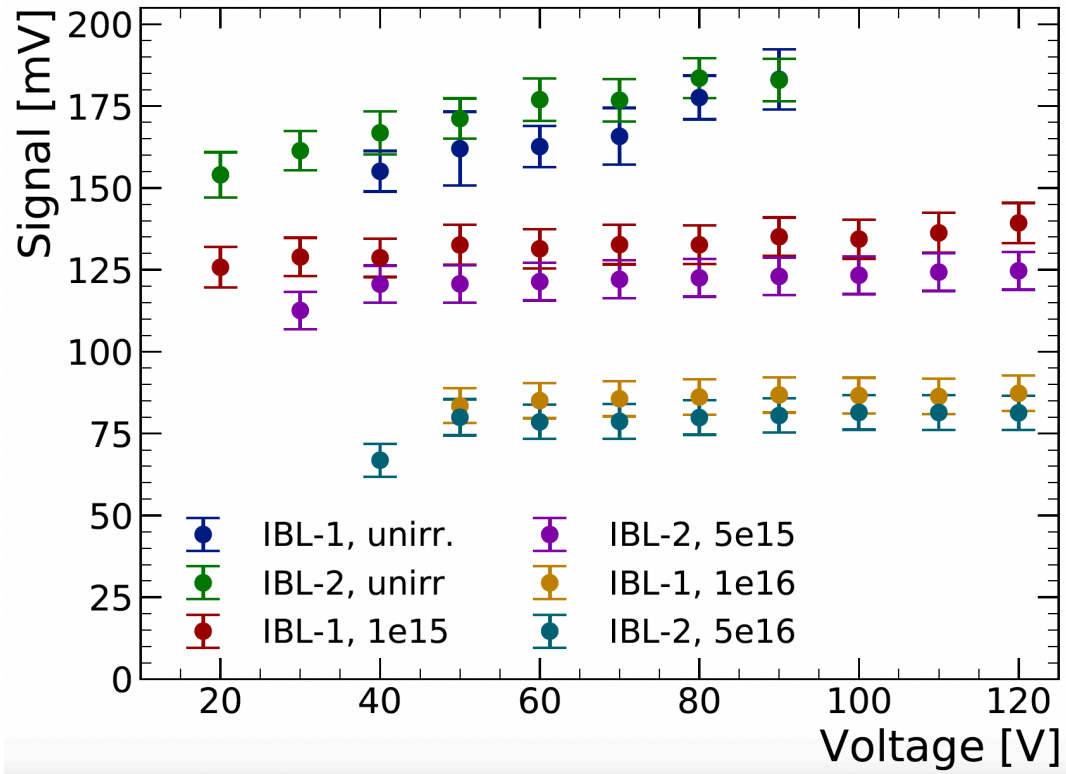
- ^{90}Sr -source
- Well known LGAD reference, $\sigma_{Ref} = 25.18 \pm 0.35 \text{ ps}$
- PMT yes/no trigger

Time Resolution: 3D vs other sensors



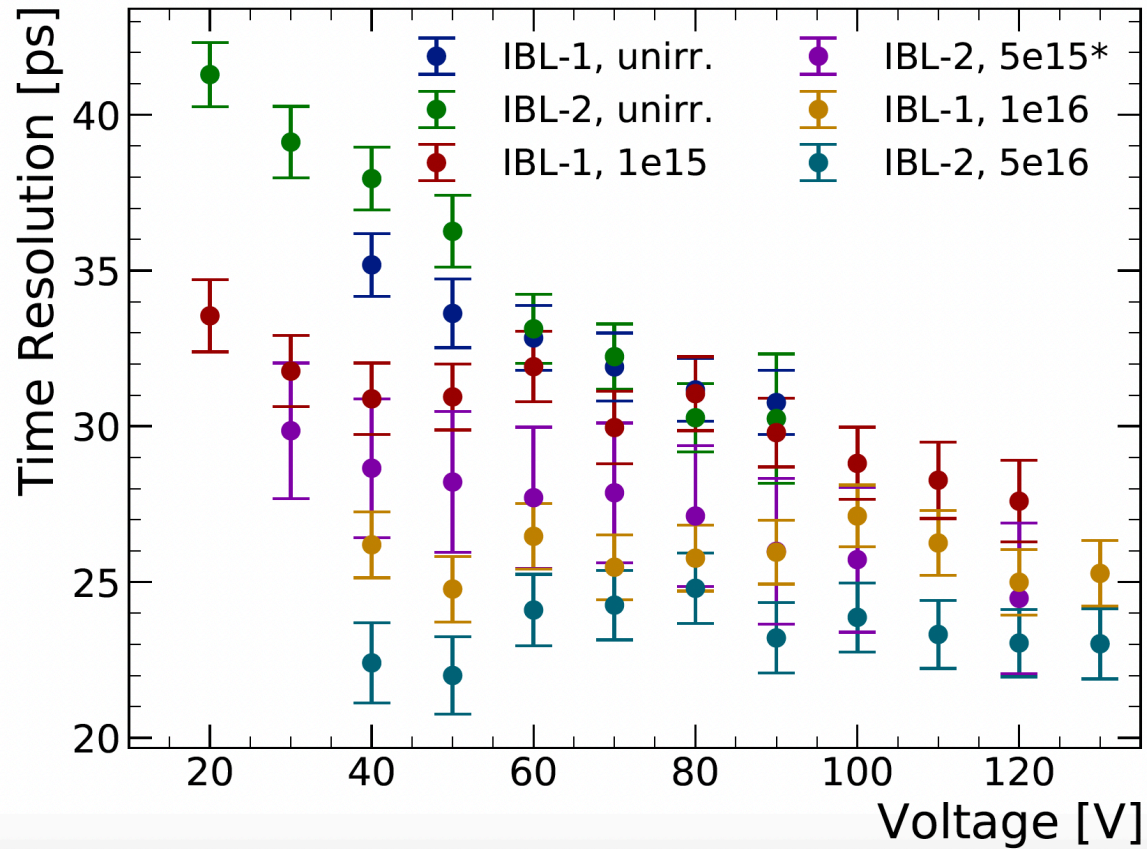
- Planar: Strips sensors - 300 μm thickness (ATLAS, Hamamatsu) and 150 μm thickness (CMOS, LFoundry)
- LGADs – Pad diodes: 50 μm thickness, high gain layer doping and 35 μm thickness, lower gain layer doping
- As expected, 3D strip sensors show better time resolutions than planar strip sensors, but only pixel sensors are competitive with LGADs
- Benefit: Lower voltage necessary for 3Ds than for LGADs

Time Resolution: Irradiated 3D sensors



- Signal decreases with fluence
- Rise time drop after irradiation
- No significant fluence dependence for rise time

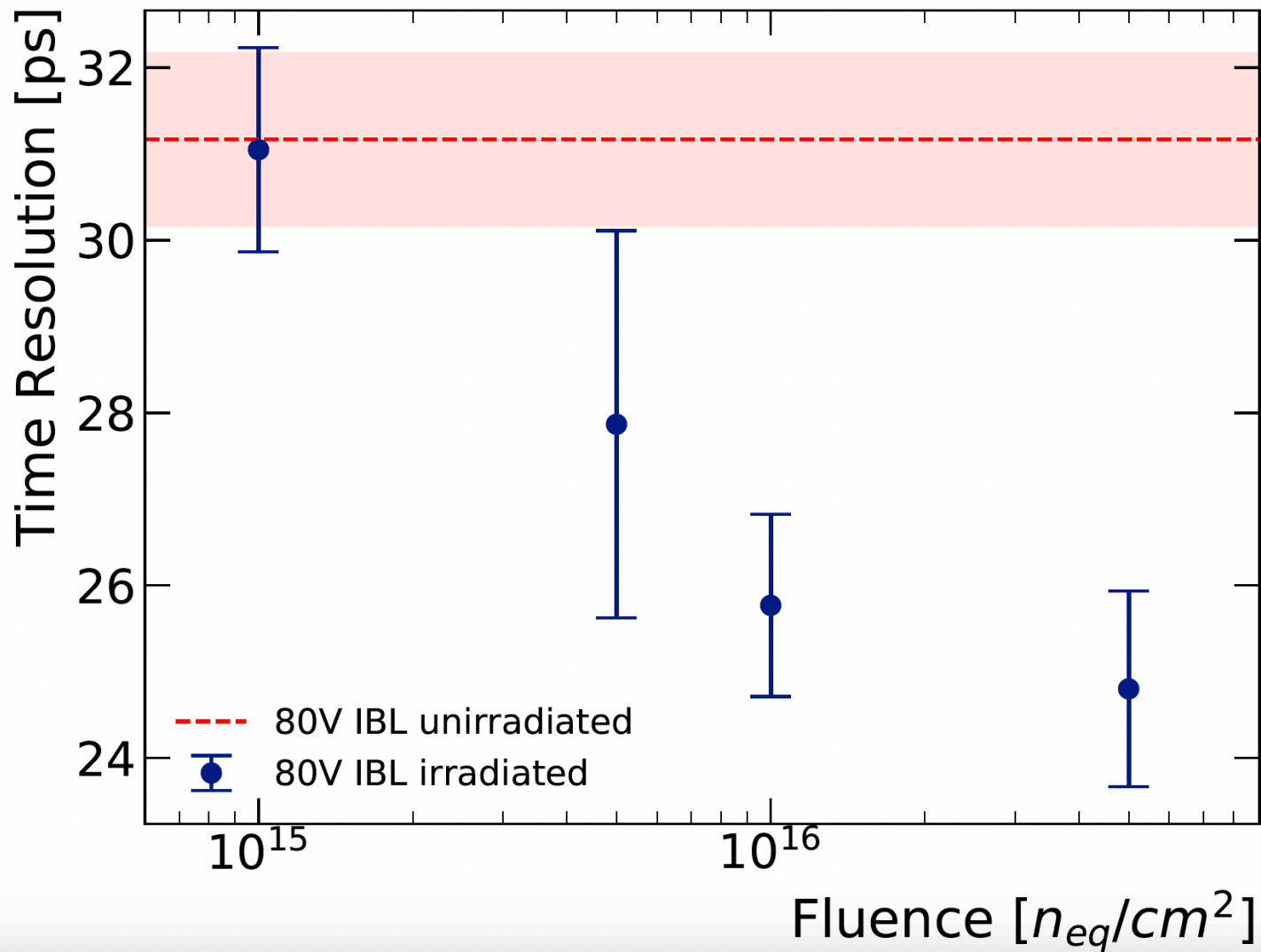
Time Resolution: Irradiated 3D sensors



- Slightly higher bias voltages necessary
- No clear voltage dependence for highest fluences
 - Might be biased by low (and slower) signals not recorded at low voltages
- Time resolution seems to be slightly improving with fluence

* measured with different trigger setup

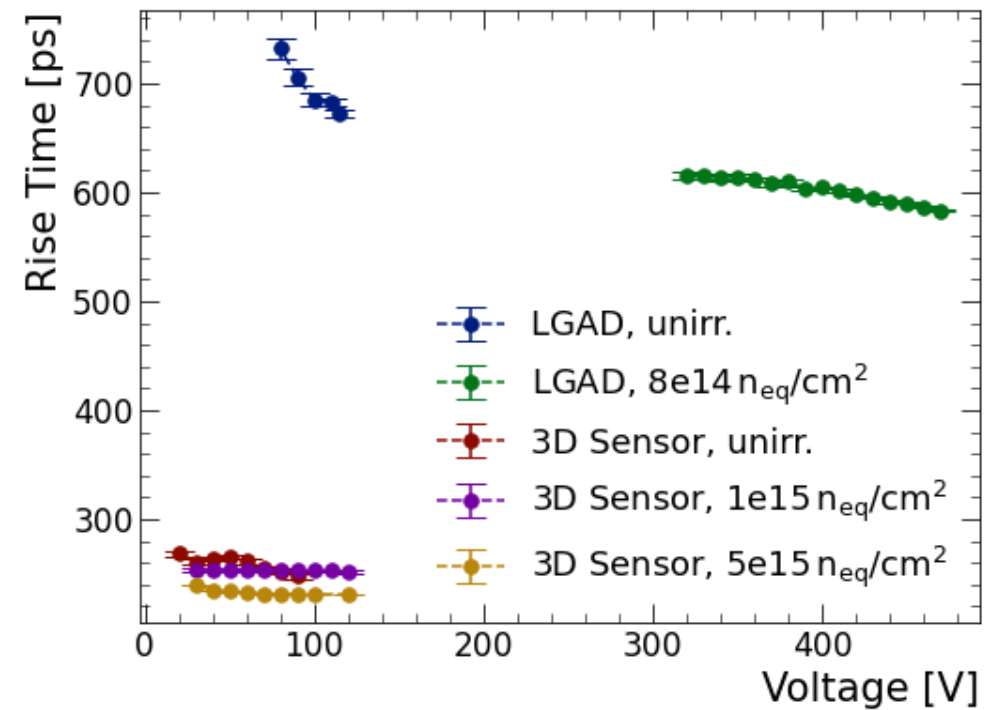
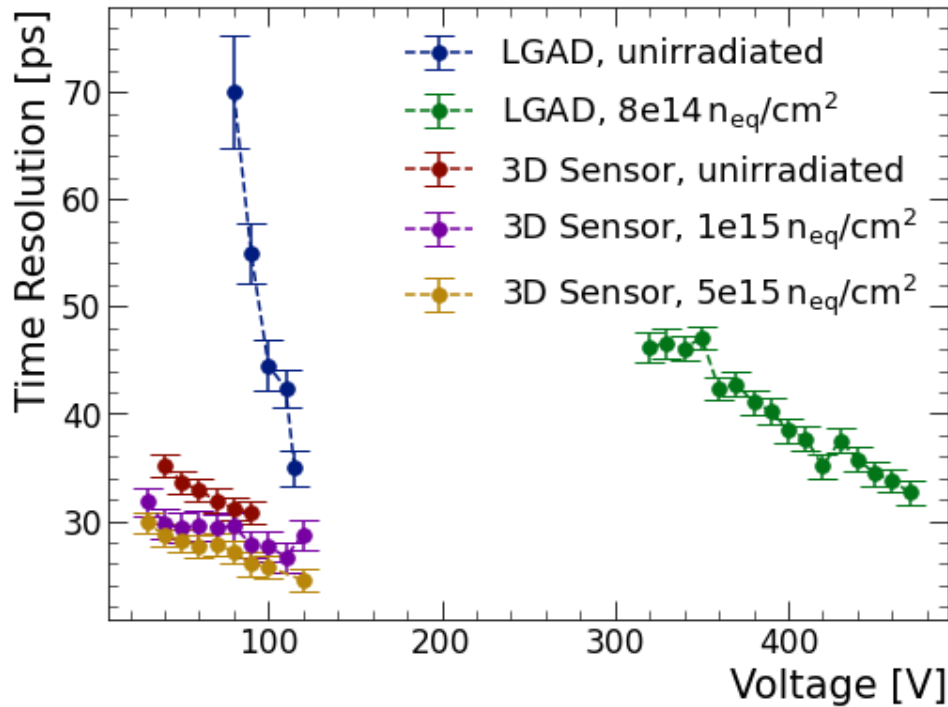
Time Resolution vs Fluence



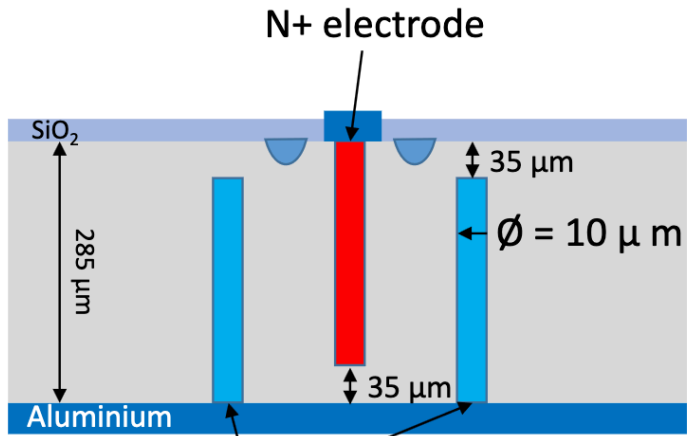
- Measured at 80V
- Time resolution improves with increasing fluence
- Higher electric field between columns improves timing

Comparison - LGAD vs 3D Pixel after irradiation

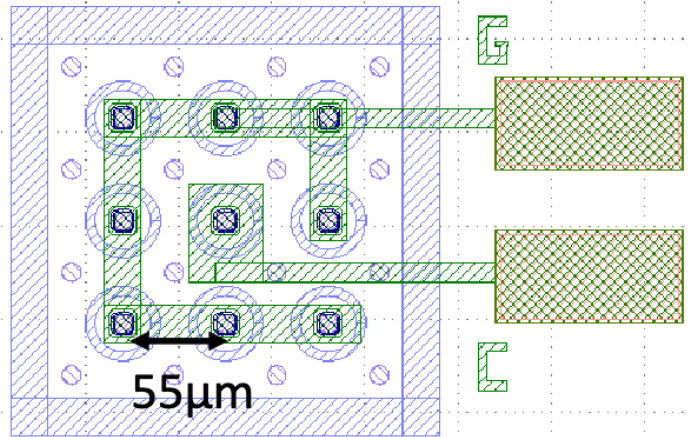
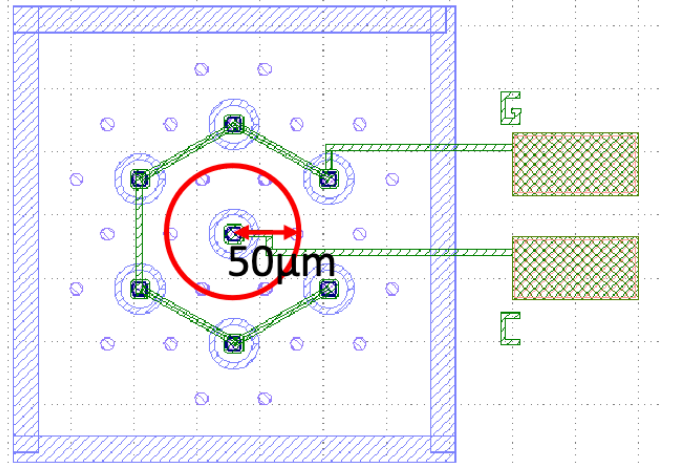
- Significantly lower rise time
- For these 3D pixel and LGAD types: 3D sensors perform better in timing measurements
- Note: This are not the latest/ fastest generation of LGADs – but the 3D sensors prove to be competitive



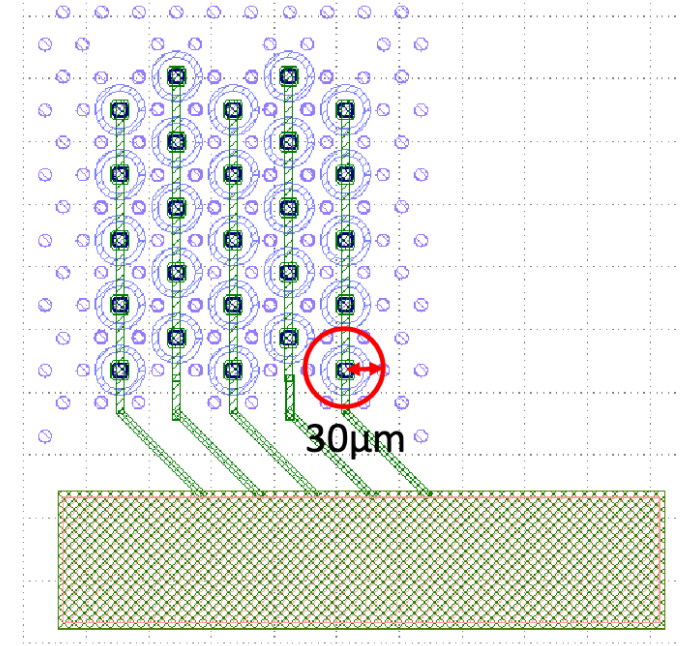
New Timing 3D sensors



- 3D doublesided technology
- Hexagonal geometry, quadratic for comparison
- 285 μm active thickness
- 10 μm column diameter



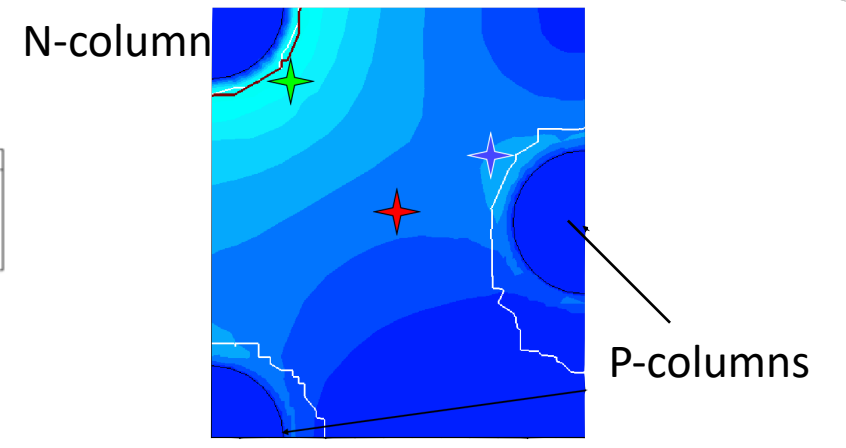
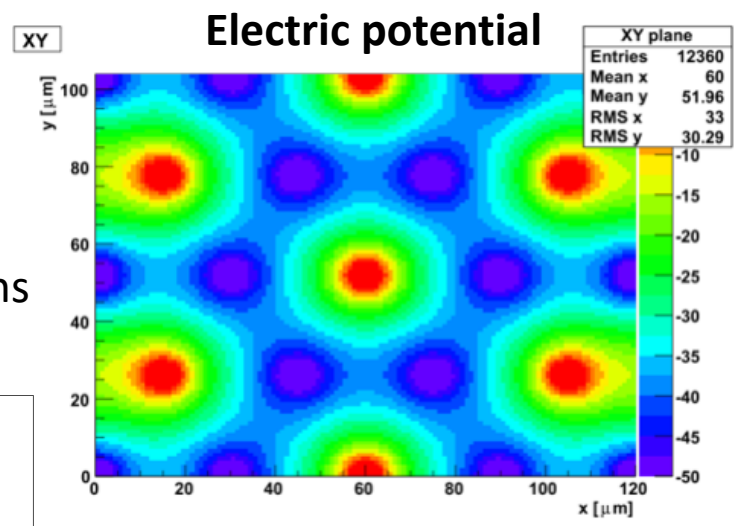
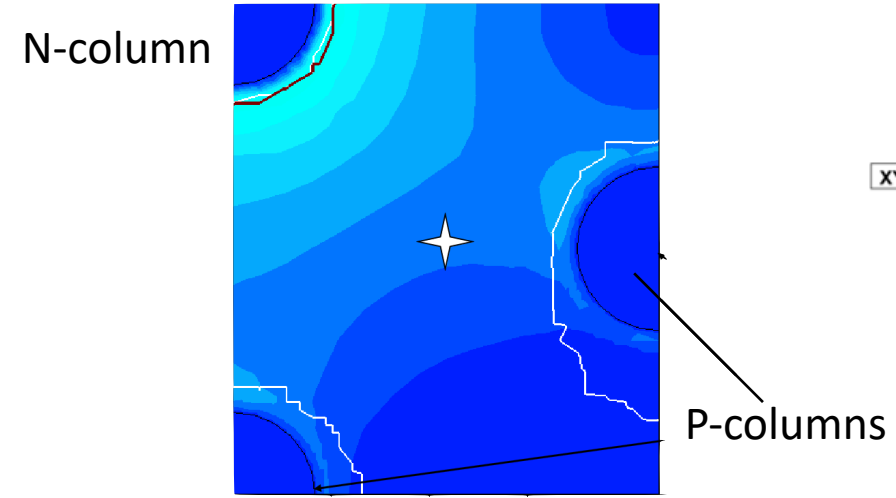
Designed and produced by CNM



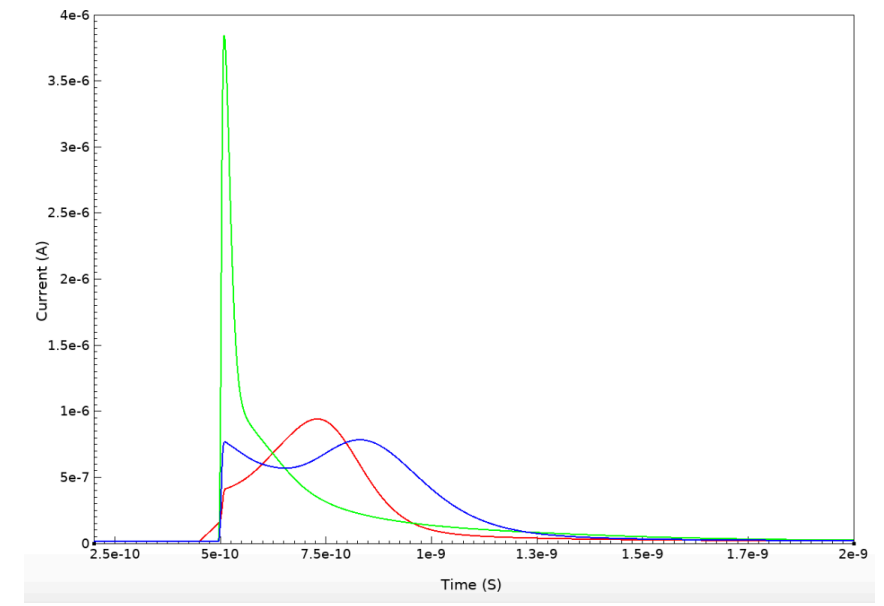
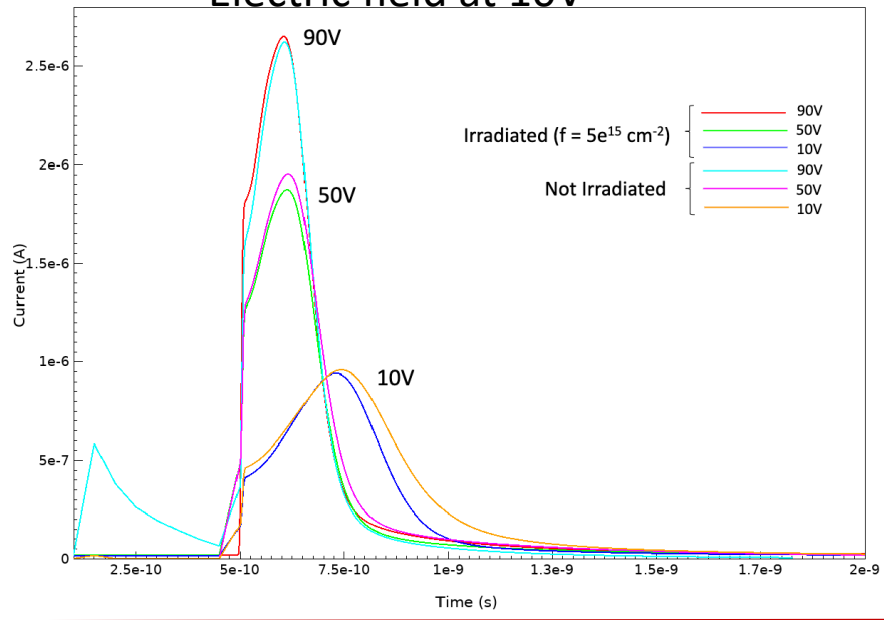
RD50 common fast timing project:

CNM, Uni Freiburg, JSI (Ljubljana), IFAE (Barcelona), NIKHEF (Amsterdam), UZH (Zurich), Uni Bonn

New Timing 3D sensors: Simulations

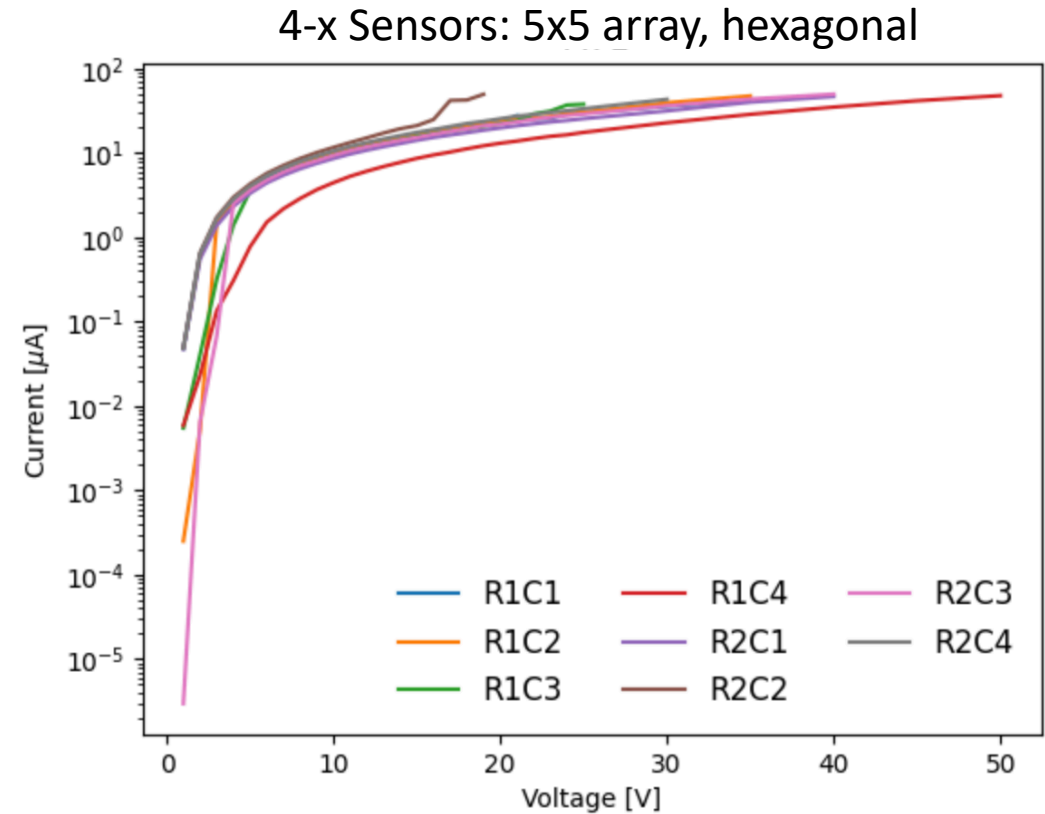
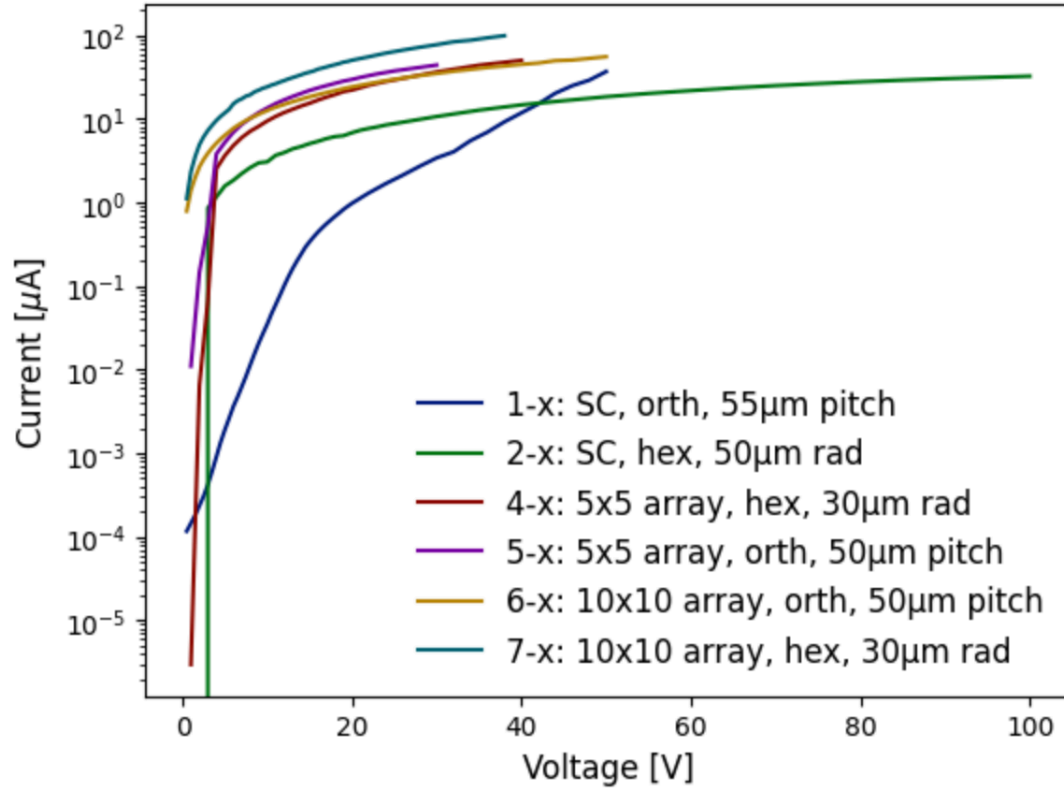


Waveforms @10V, $f = 5e15 \text{ cm}^{-2}$



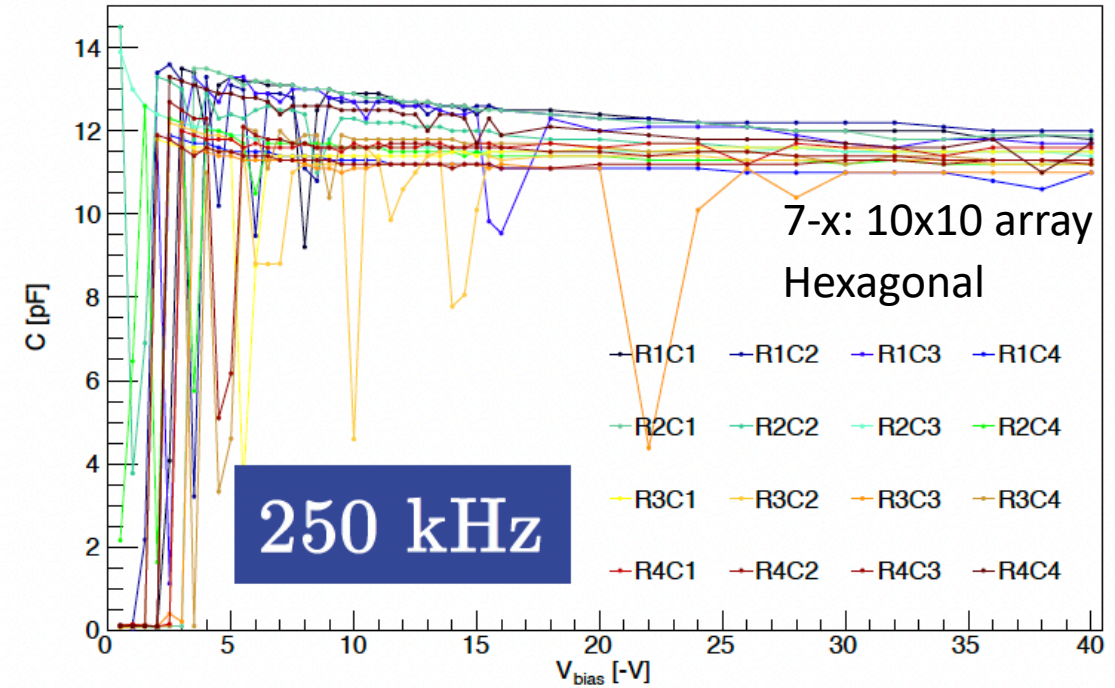
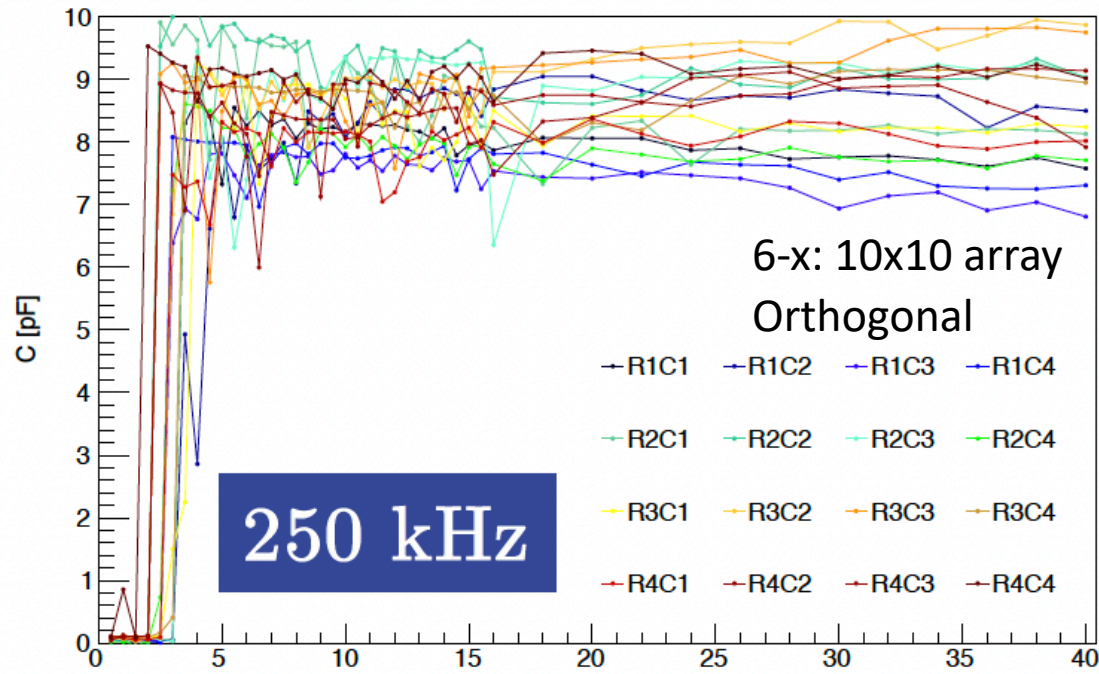
No zero field spots

New Timing 3D sensors: IVs



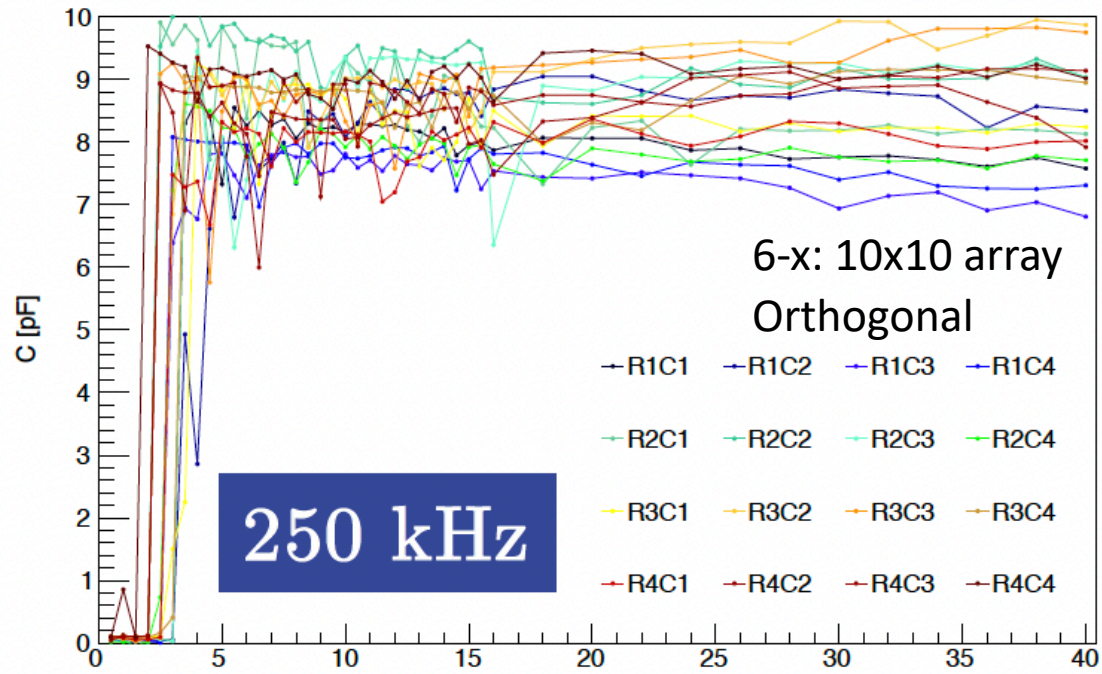
- 7 different sensor types measured: higher currents for larger structures
- All currents in the expected range for 3D sensors
- Several devices per type available: All functional, timing measurement campaign to be started

New Timing 3D sensors: CVs

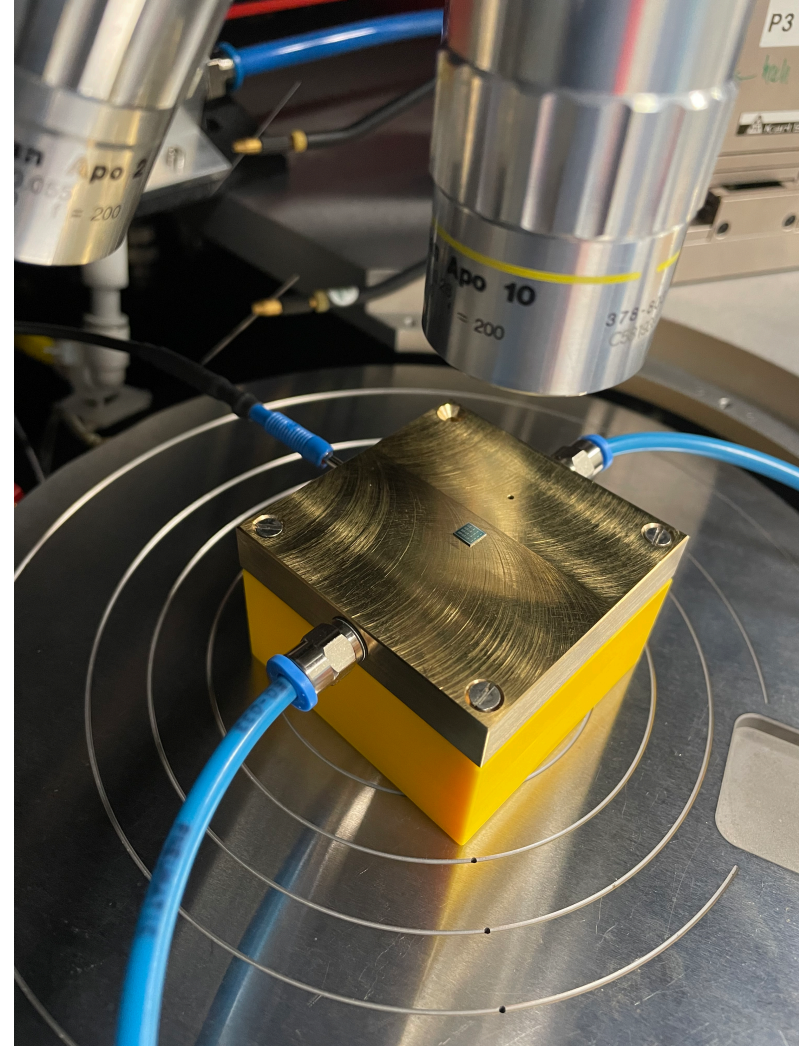


- Measurements done in probe station, sensor directly on the chuck
- Large fluctuations, especially at low voltages
- The chuck seems to influence the measurement at low voltages

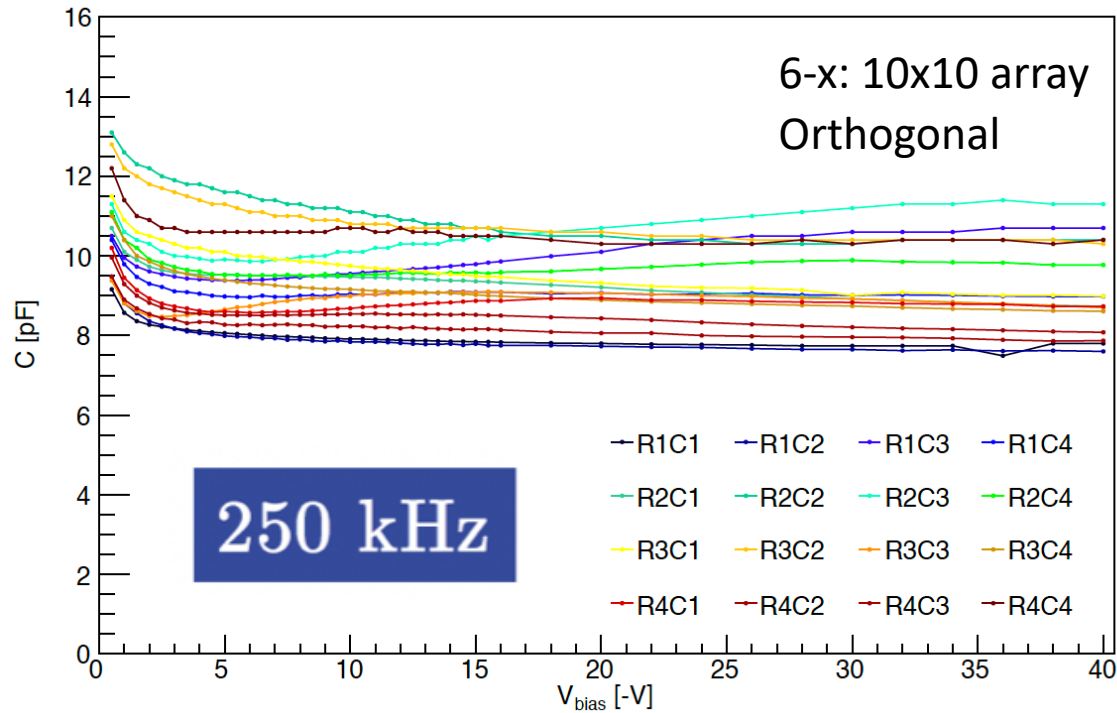
New Timing 3D sensors: CVs



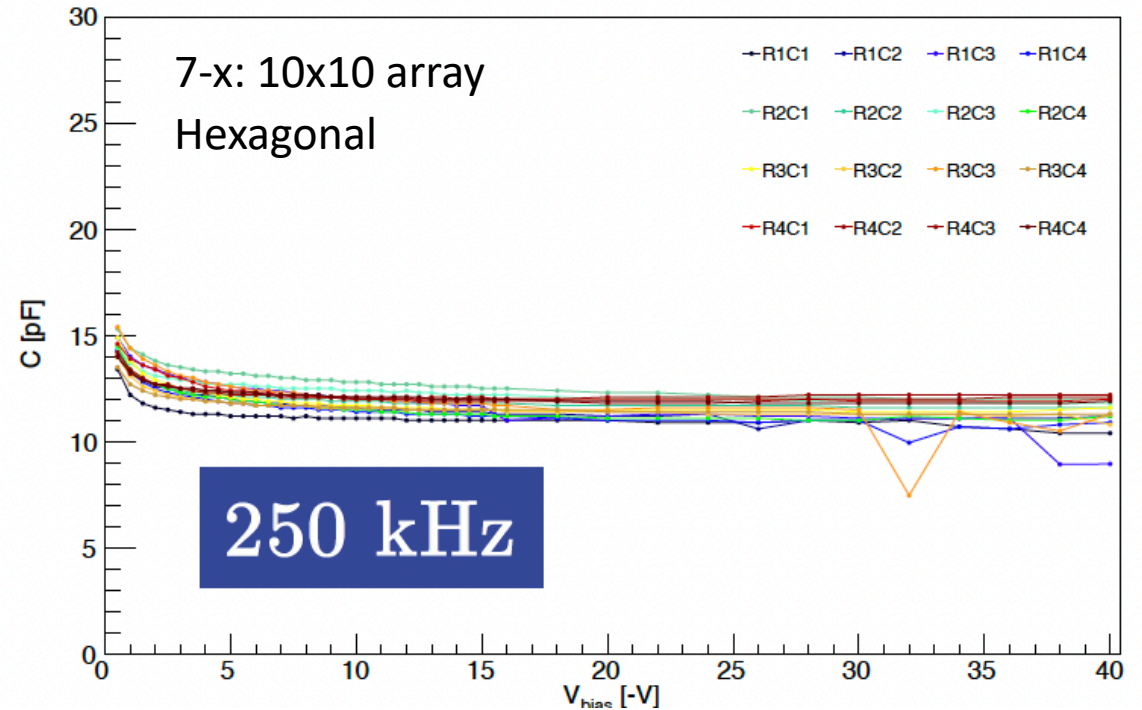
- Measurements done in probe station, sensor directly on the chuck
- Large fluctuations, especially at low voltages
- The chuck seems to influence the measurement at low voltages
 - ➔ Adding an electrically isolated additional chuck



New Timing 3D sensors: CVs



- Issues is resolved by the additional small chuck
- Measurements of all sensor types now ongoing



- Depletion voltages are all below 5V
- Low Capacitance: Less than 15pF for the largest arrays

Conclusion and Outlook

- Time resolution of silicon sensors is an important research area for upcoming and future colliders
- Before irradiation, both 3D sensors reach time resolutions of 30-35 ps, comparable to LGADs
- 3D pixel sensors improve resolution after irradiation while the bias voltage range stays almost the same
- 3D pixels withstand $5 \times 10^{16} n_{eq}/cm^2$ while keeping their timing performance
- RD50 project - Dedicated timing sensors:
 - Hexagonal geometry, IV measurements completed, CV measurements ongoing and timing measurements to be started soon
- Irradiation campaign to high fluences planned



Thank you for your attention!

Big thank you to Valentina, Nicolo and the Torino team for the LGADs we could use for comparison!



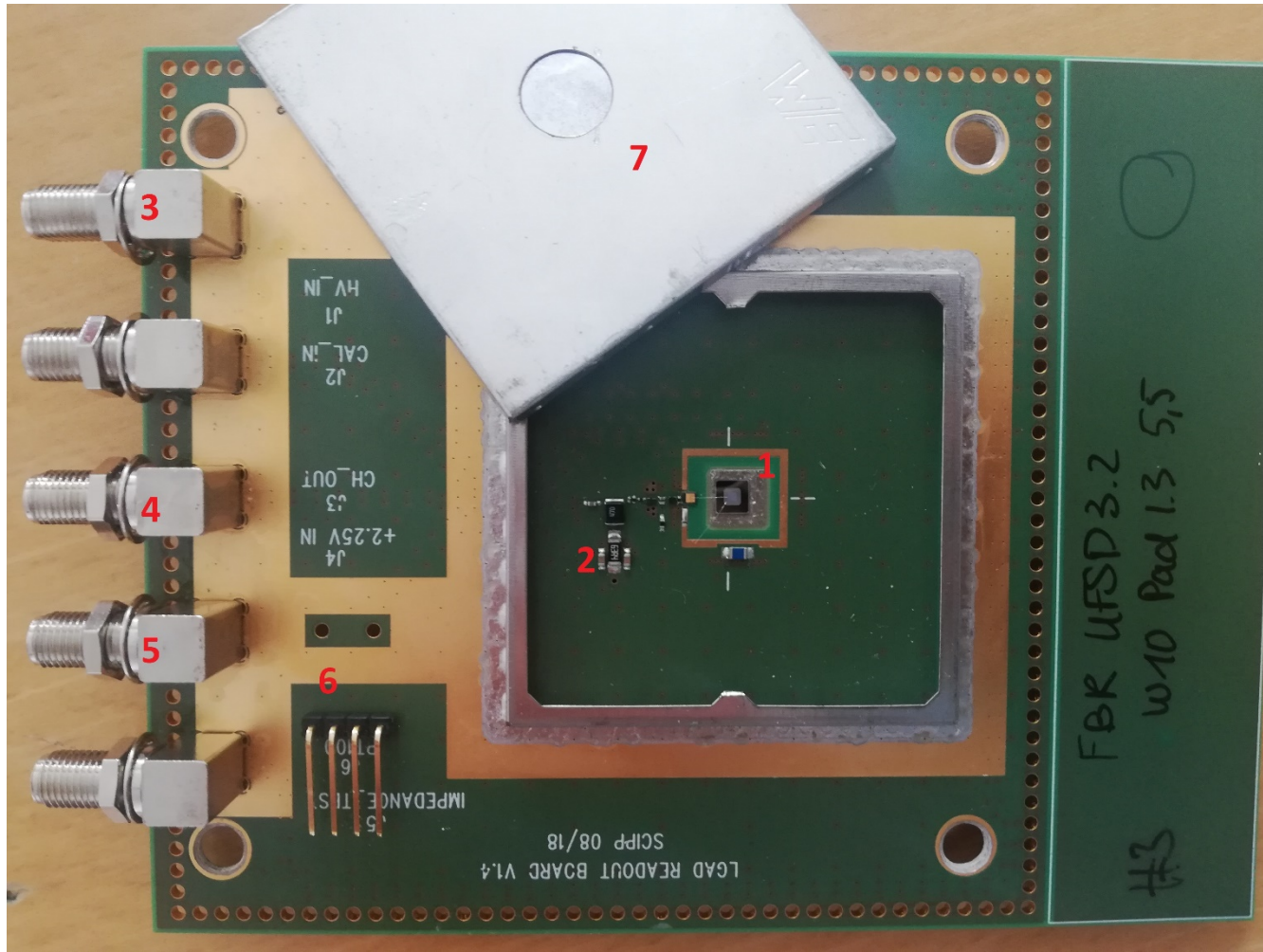
BACKUP

Albert-Ludwigs-Universität Freiburg



**UNI
FREIBURG**

LGAD Readout Board



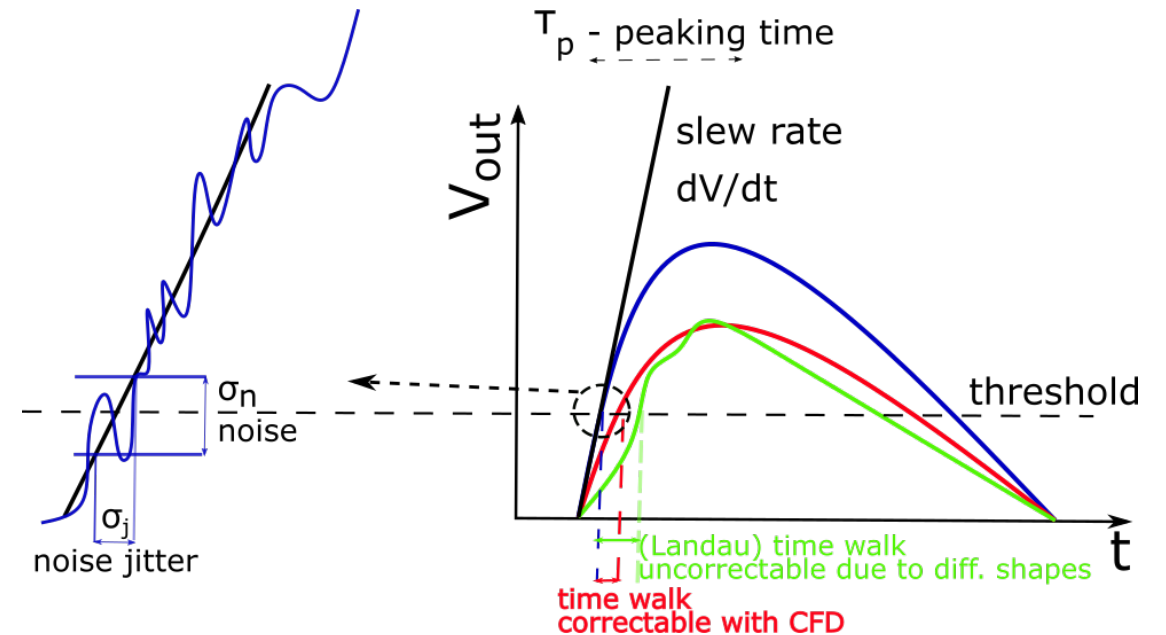
1. Bonded LGAD
2. Amplifier
3. High voltage connector
4. Readout connector
5. Low voltage connector
6. PT100 connector
7. Lid

Time Resolution - Components

- Main components: Jitter and time walk: $\sigma_t^2 = \sigma_j^2 + \sigma_{TW}^2$
- Jitter component σ_j : Determined by the rise time at the amplifier output dV/dt and the noise level σ_n :

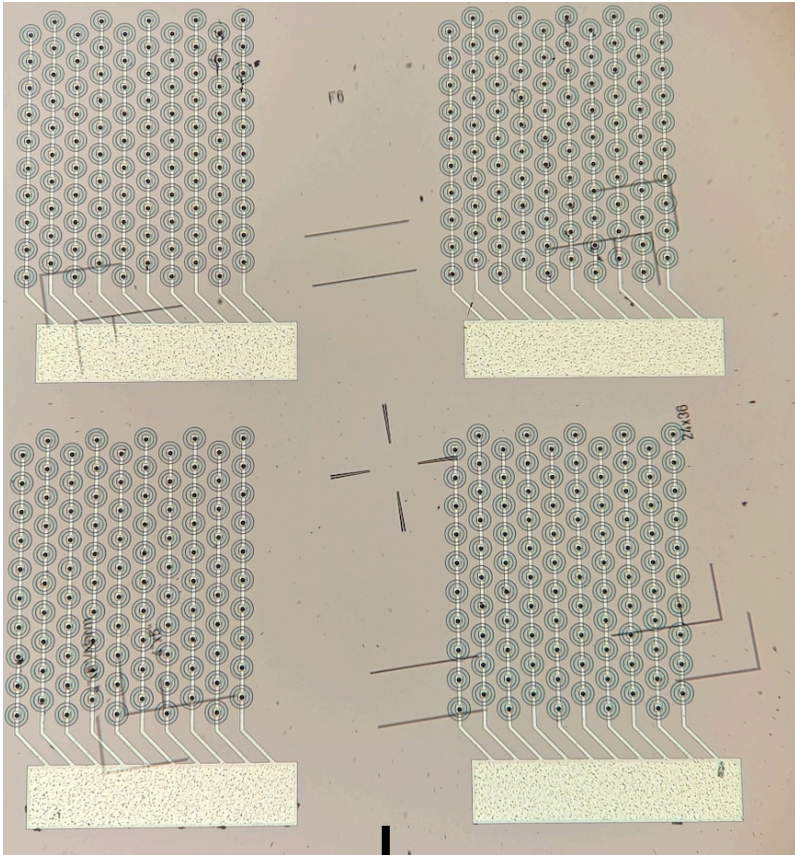
$$\sigma_j = \frac{\sigma_n}{|dV/dt|} \approx \frac{\sigma_n}{|S/\tau_p|} = \frac{\tau_p}{S/N}$$

- Time walk component includes:
 - Weighting field/ el. Field contribution
 - Landau fluctuations in signal shape
 - Landau fluctuation in the amount of deposited charge (correctable)
- Time Walk component depends strongly on the sensor design

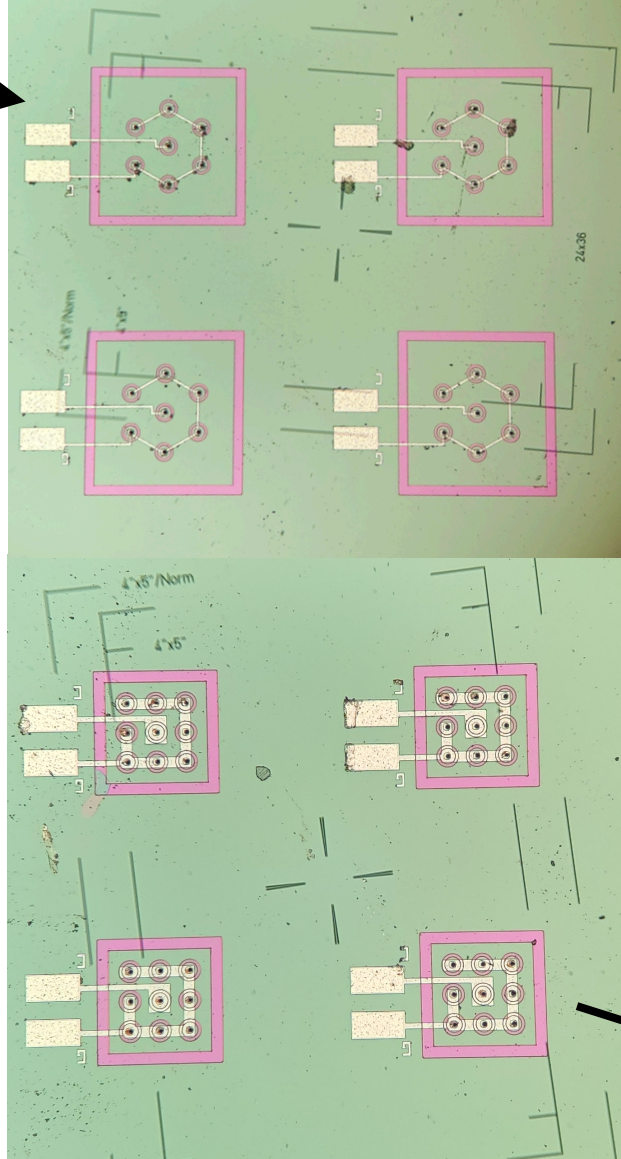


New Timing 3D sensors

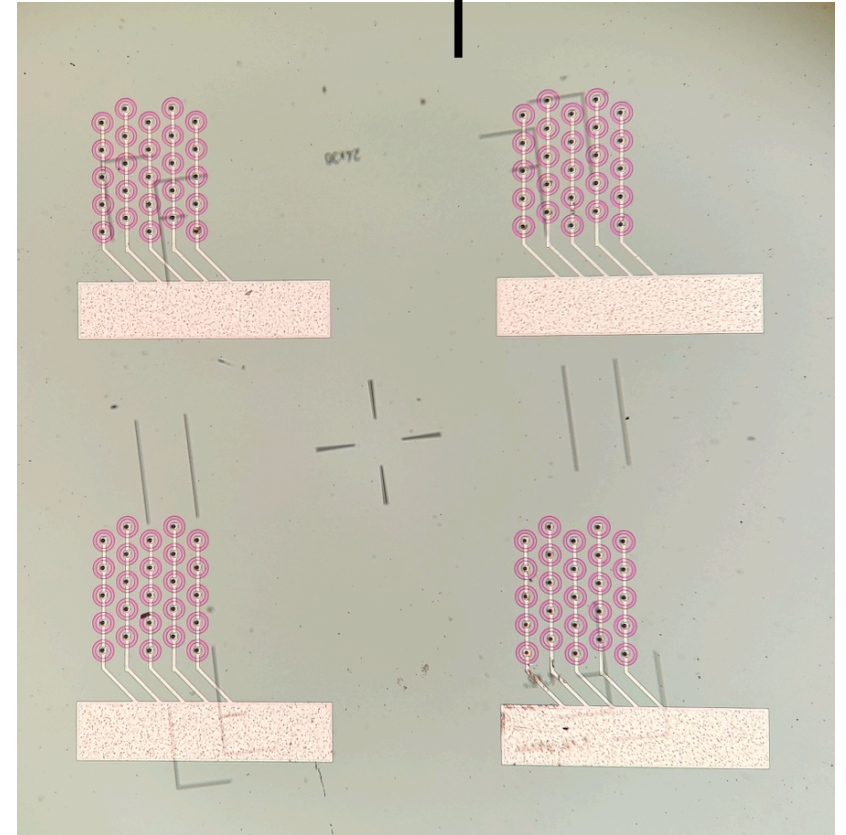
2-x: SC, hexagonal, 50 μm rad



7-x: 10x10 array, Hexagonal, 30 μm rad



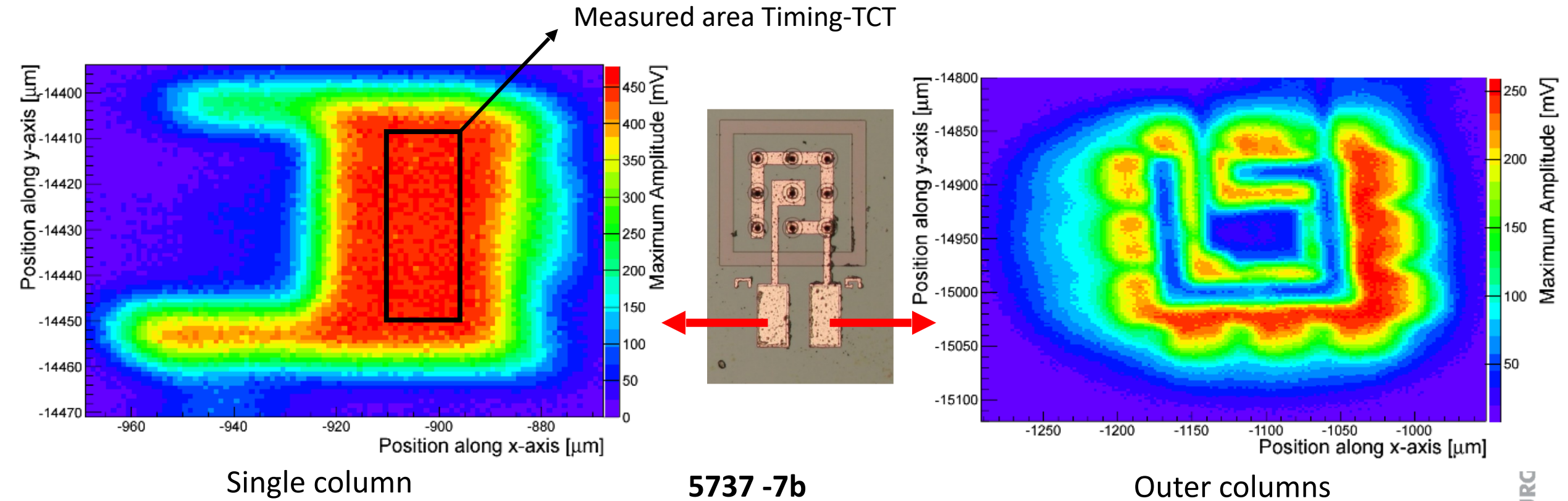
4-x: 5x5 array, Hexagonal, 30 μm rad



1-x: Single channel, orthogonal, 55 μm

TCT area scans: 3D Pixel Sensors

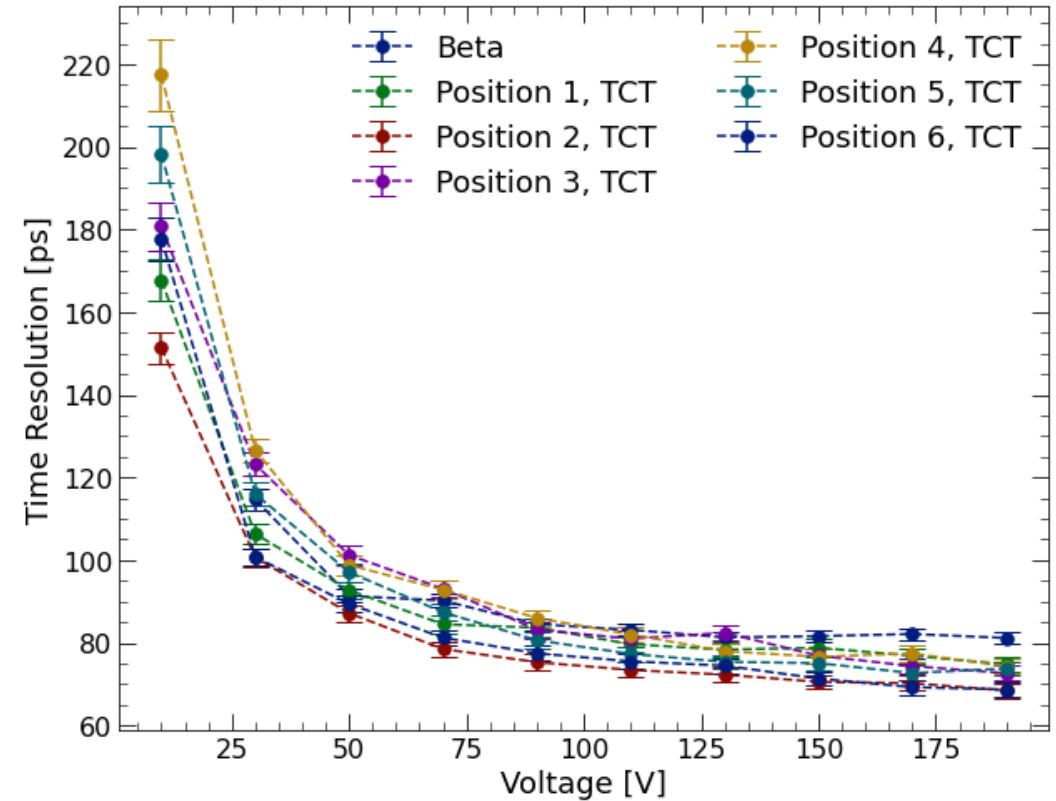
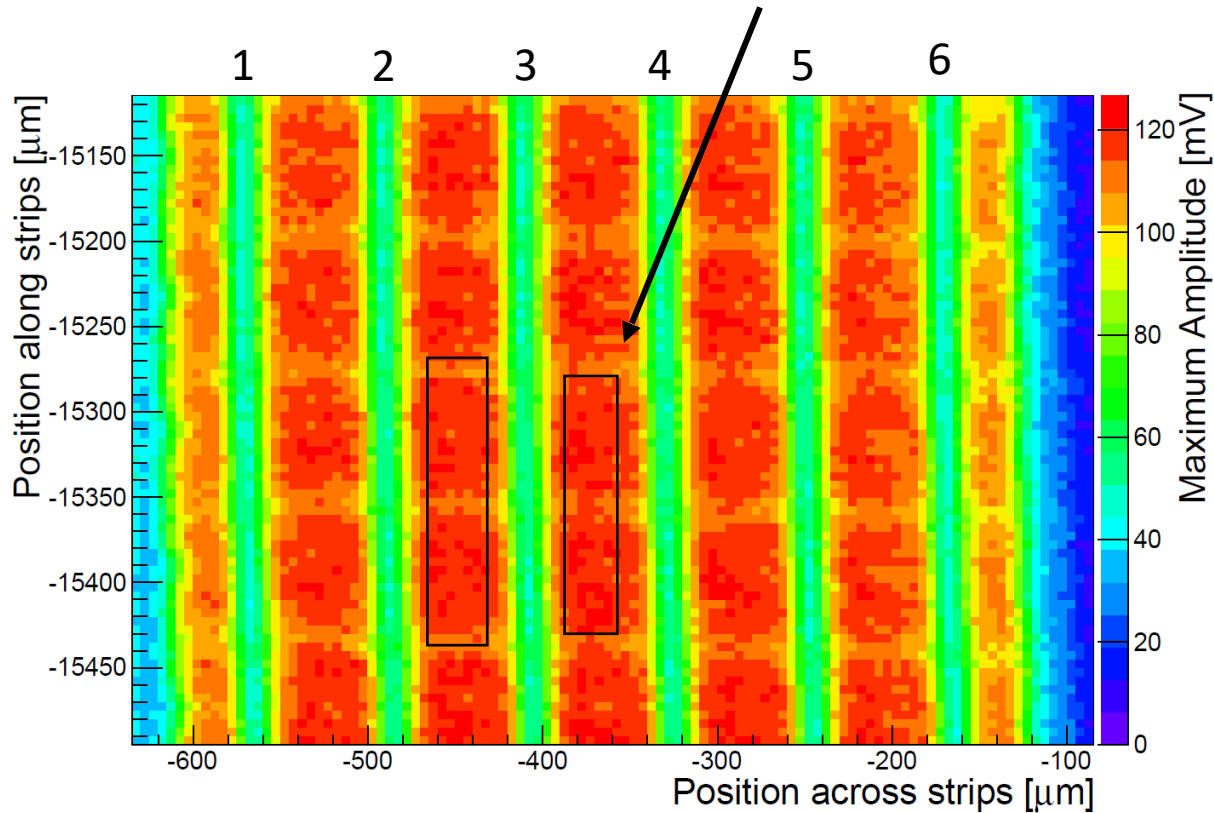
- TCT scans show very small measurable area for Timing-TCT
- Outer columns connected – indefinite electric field outside the cell



Time Resolution: 3D Strip Sensor

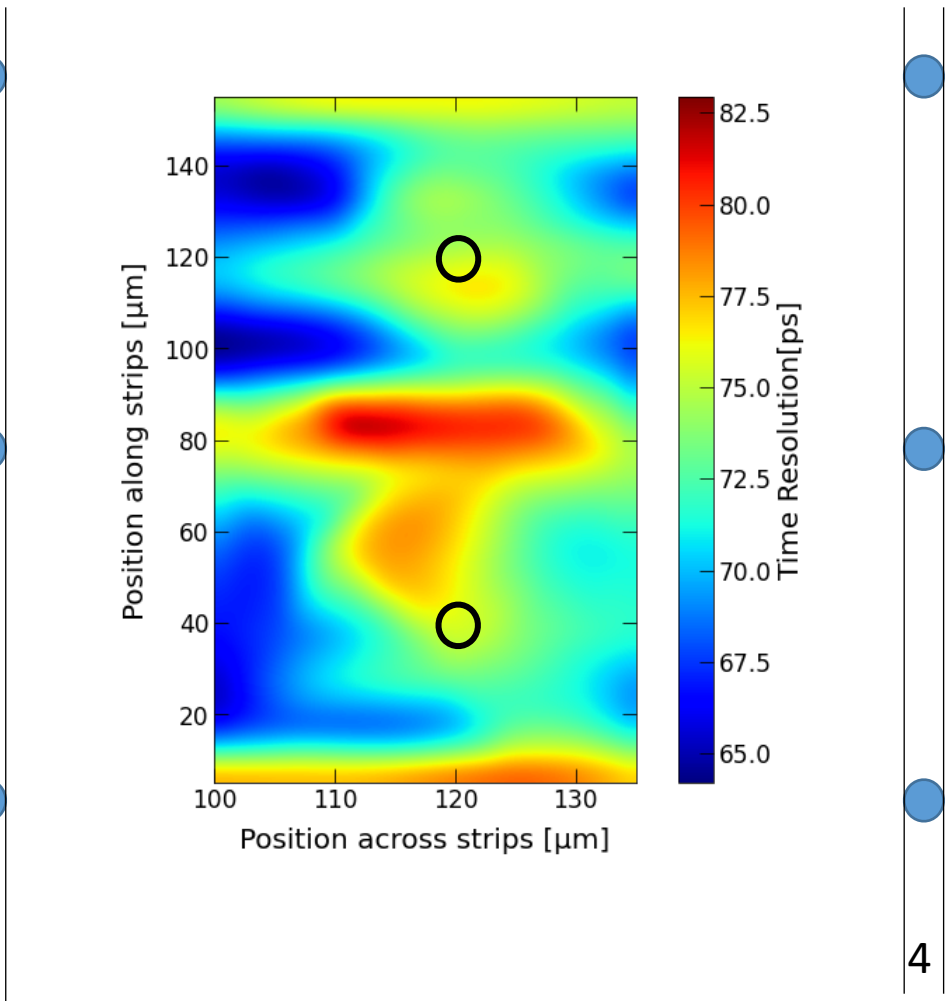
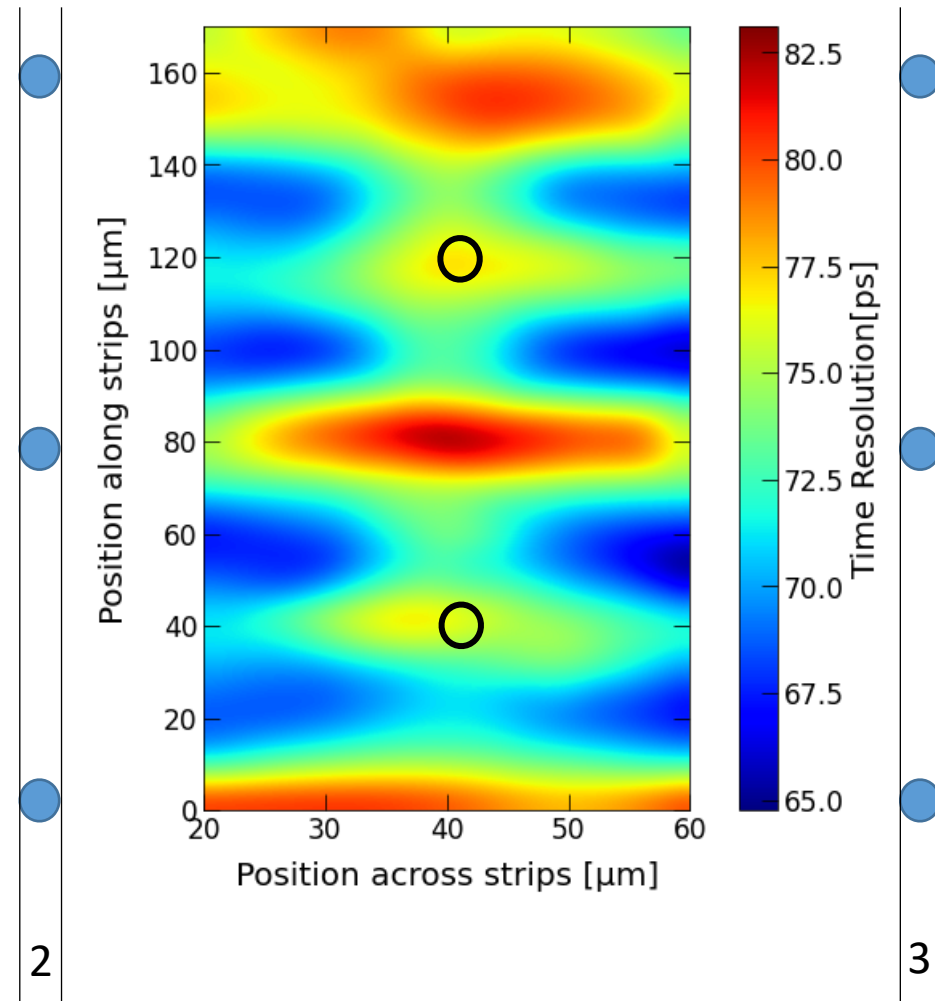
- 3D strip sensor: 235 μm thickness, $80 \times 80 \mu\text{m}^2$ cell size, 6 channels connected to readout
- Measured with TCT and Timing Set-Up
- For high voltages: Time resolution of about 75 ps reached

Measured areas for TCT-Timing



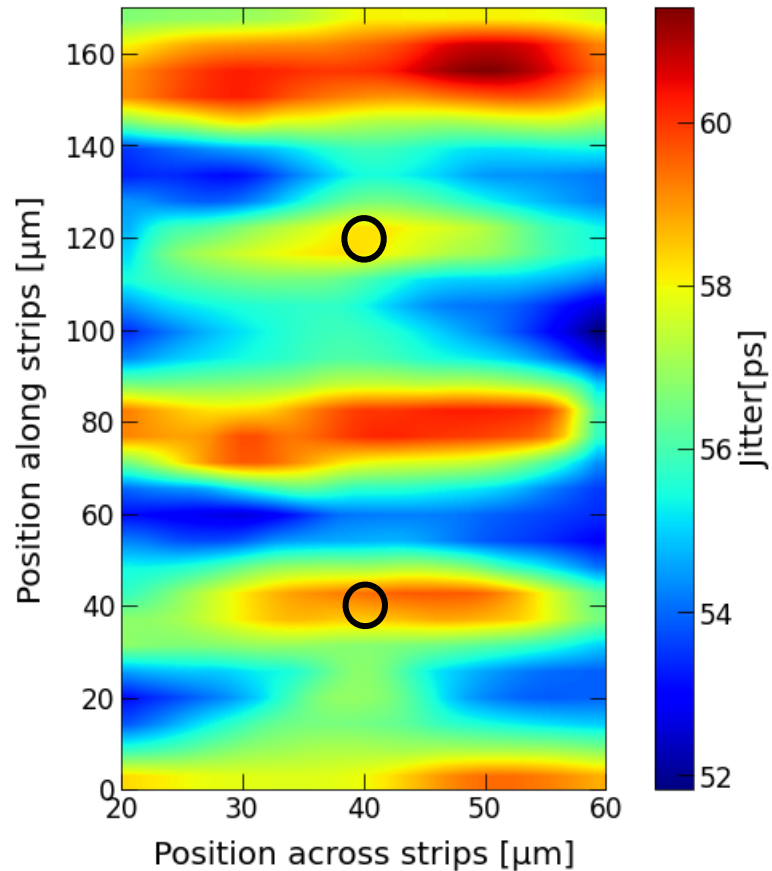
Time Resolution: 3D Strip Sensor

Position dependent measurement of the time resolution with the TCT, measured at 150 V

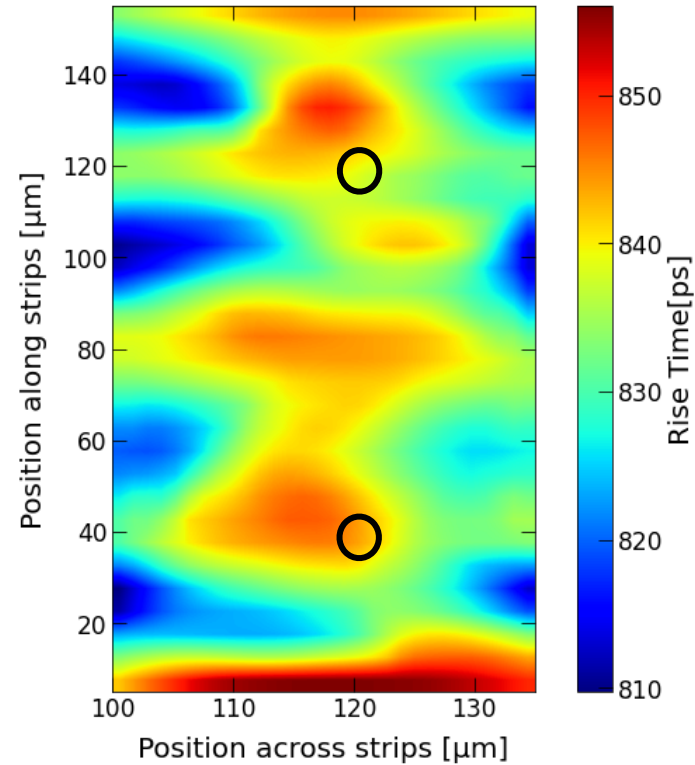


- Clear cell structure
- Worse resolution between junction columns ●
- Worse resolution around ohmic columns ○
- Resolution correlates to the expected el. Field
- Resolution between 65 and 83 ps

Time Resolution: 3D Strip Sensor



2 3

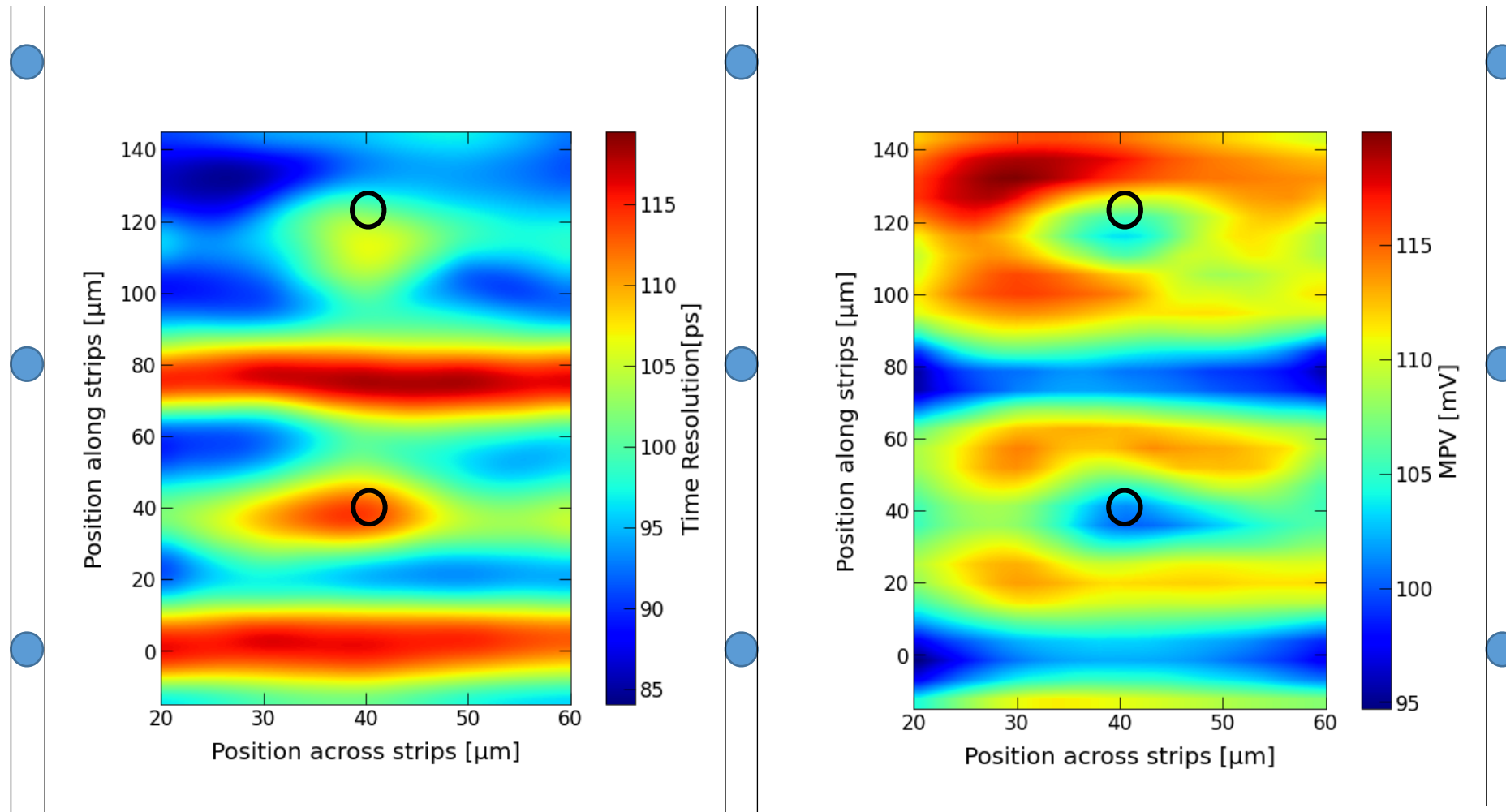


4

- Clear cell structure
- Similar patterns for jitter and rise time
- Both correlate to the expected el. Field
- Rise Time between 810 and 855 ps
- Jitter higher than in Beta Set-Up, 52-62 ps

Time Resolution: 3D Strip Sensor 2

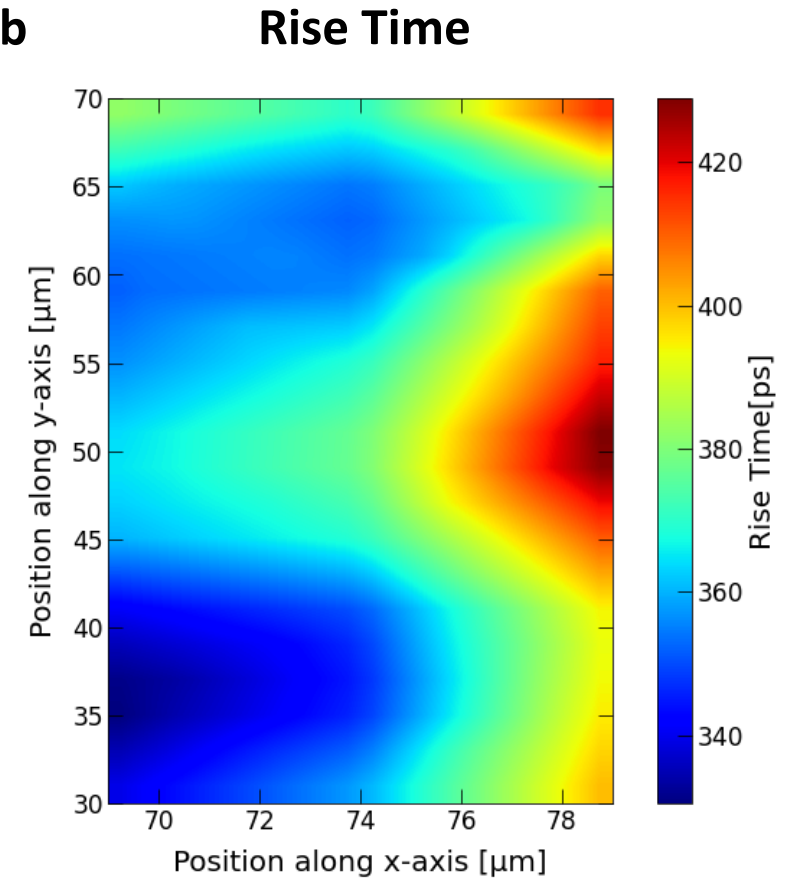
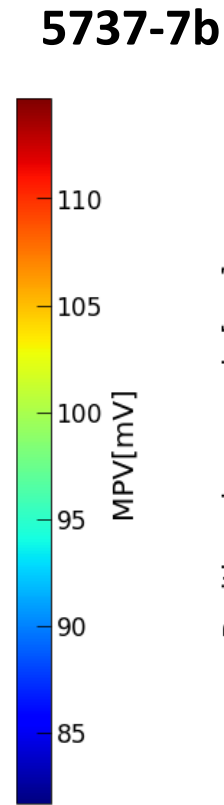
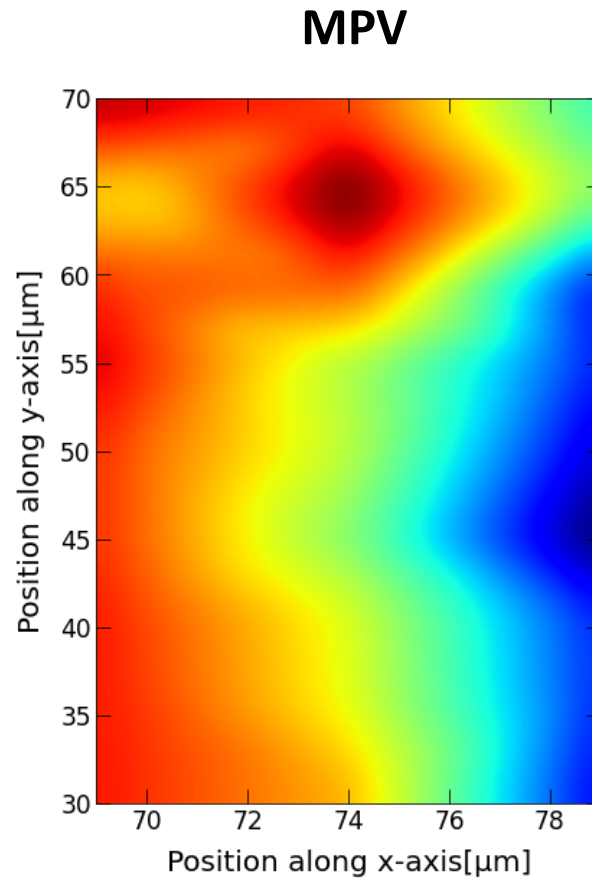
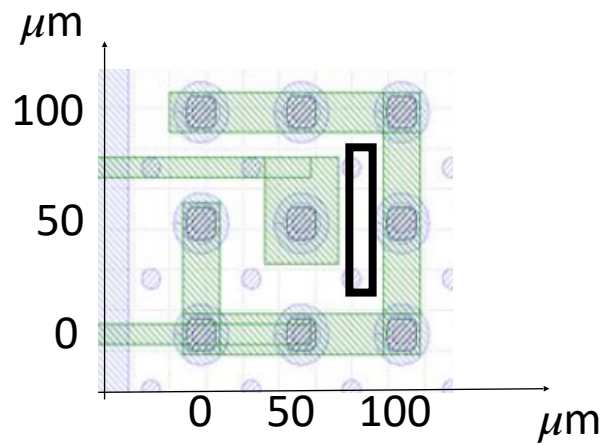
5936-4 Strip Sensor: 285 μm thick, high leakage current (sensor broken in half), measured at 40 V



- Clear cell structure
- Worse resolution \bullet between junction columns
- Worse resolution around ohmic columns \circ
- Resolution correlates to the expected el. Field
- Resolution between 85 and 115 ps \rightarrow lower voltage, higher noise
- Correlation also to MPV

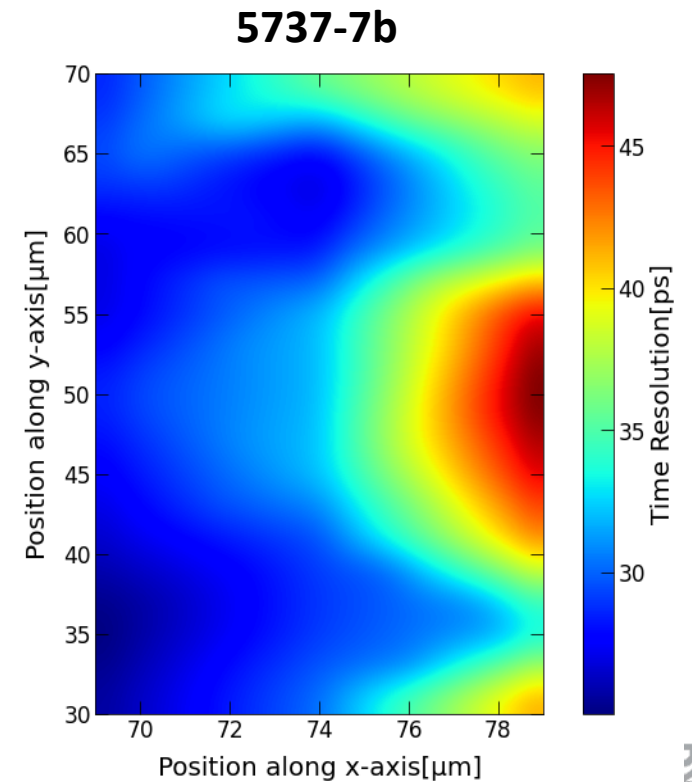
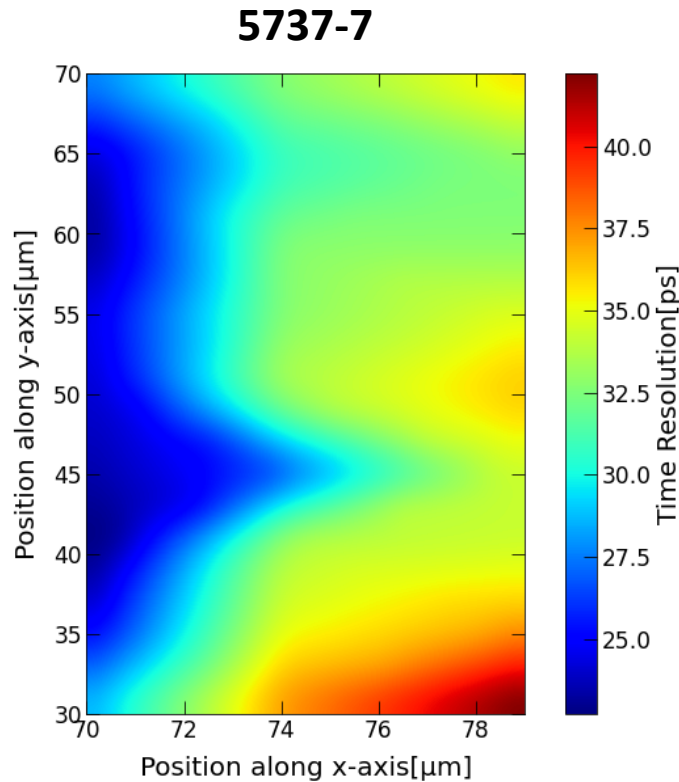
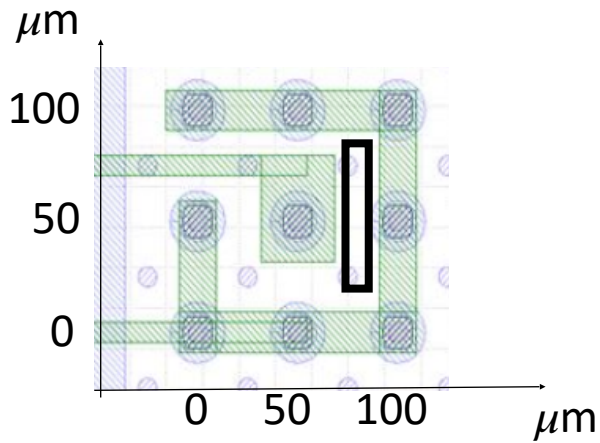
Time Resolution: Unirradiated 3D Pixel Sensors

- Low laser intensity – MPV around 80-110 mV, low compared to beta set-up (145 mV)
- Cell structure not as clear as for time resolution, but still fits the expectations
- Rise time between 340 and 420 ps, higher than measured in the beta set-up

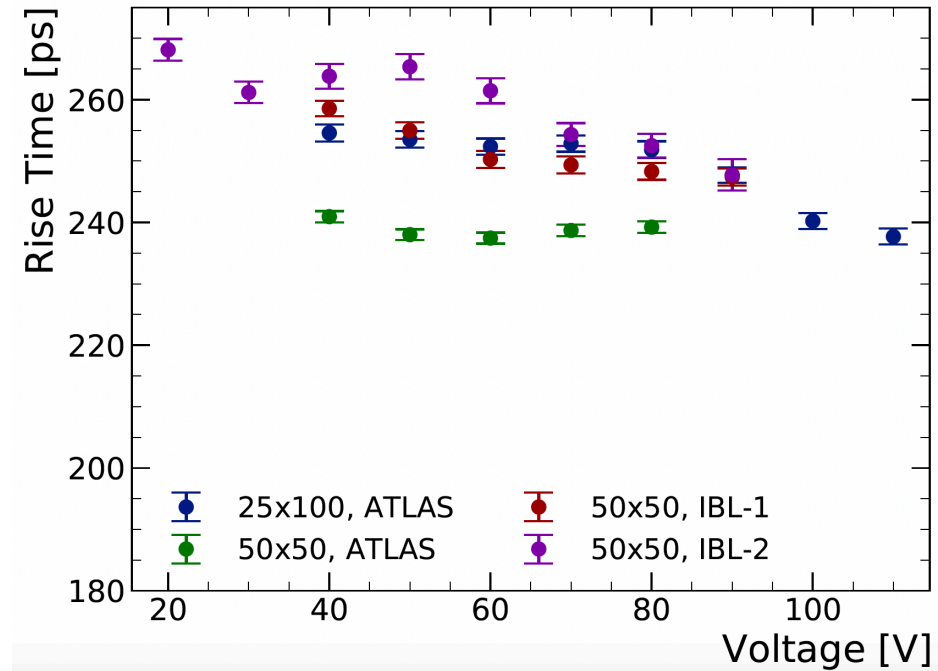
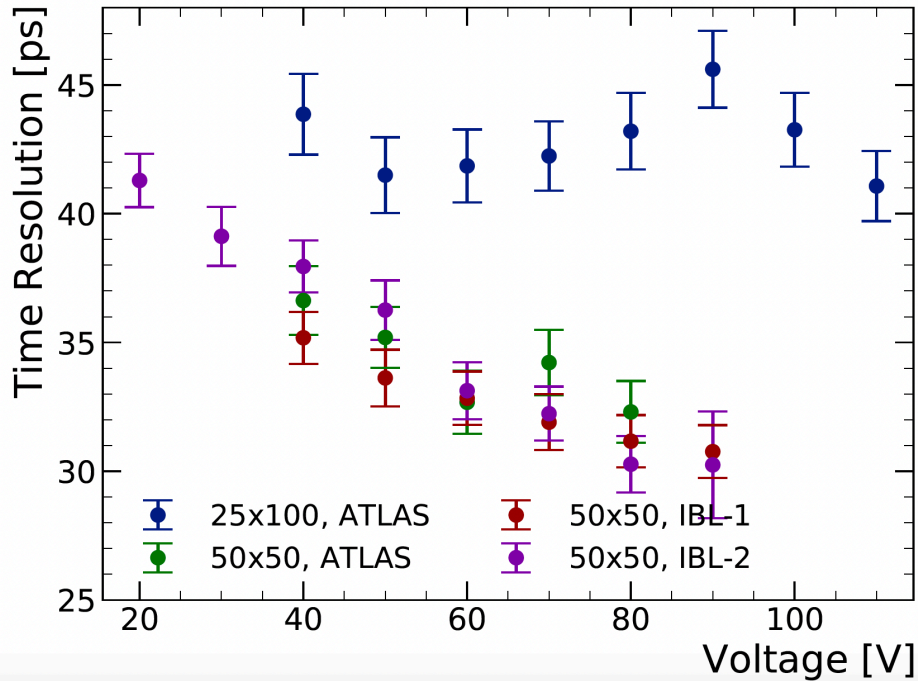


Time Resolution: Unirradiated 3D Pixel Sensors

- Time resolution measured at 60 V for a 10x40 μm area in 5 μm steps and interpolated
- Two sensors measured: Similar cell structure recognisable :
 - Better resolution closer to the readout column
 - Worse resolution closer to the other junction columns
 - Range from 23-43 ps/ 25-47 ps
- Differences: Uncertainties in position, laser focus, laser intensity



Time Resolution: Unirradiated 3D sensors

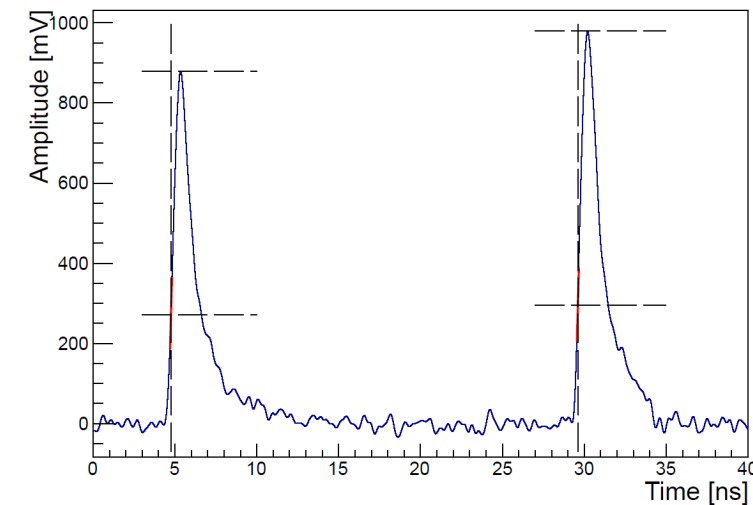
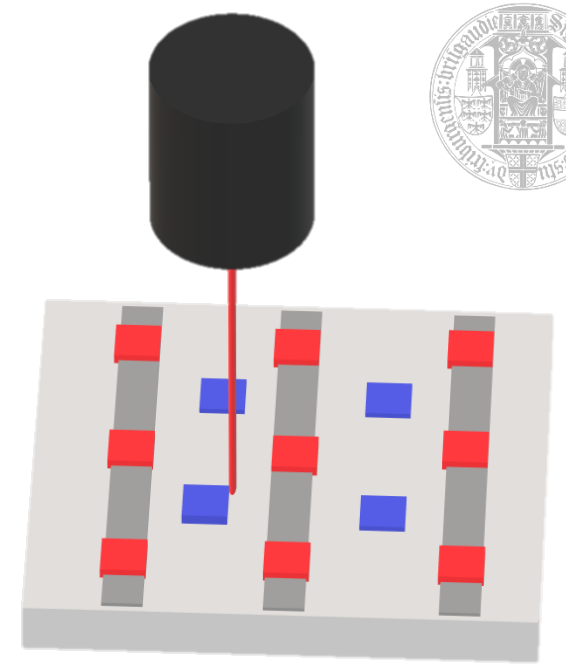


- Before irradiation, sensors reach about 30-31 ps time resolution at room temperature
- Quadratic geometry performs better
- ATLAS and IBL sensors perform very similar, slightly better rise time (240ps) for ATLAS sensor

TCT Set-Up for Timing

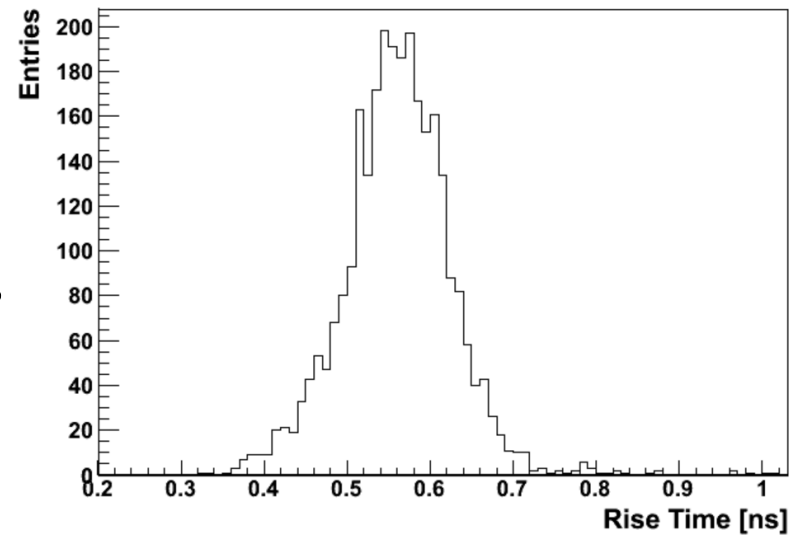
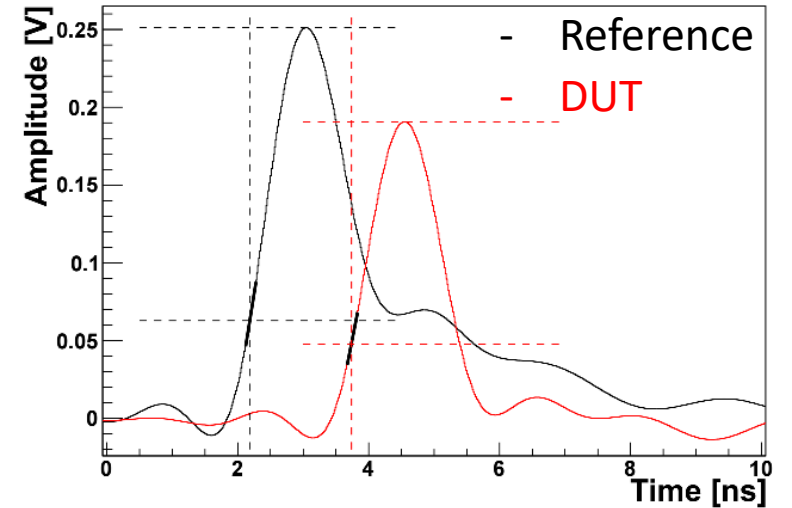


- **Transient Current Technique:** Charge created by a short laser pulse
- The current arising from the created e/h-pairs is amplified and then recorded with an oscilloscope
- **Top-TCT:** Laser on sensor surface, laser wavelength 1060 nm (infrared)
- **First:** Scanning the sensor area to determine the position of the columns
- For each specific position on the sensor: 3000 single events recorded
- Two pulses recorded per event: Using a fiber splitter and a cable (25 ns delay)



Time Resolution: Analysis

- Maximum amplitude for each event filled into histogram – MPV of the sensor is extracted with a Landau-Gauss-Fit
- If the maximum signal is above a threshold, events used for further analysis
- **Time of Arrival** determined with **Constant Fraction Discrimination**
- Linear fit around this point to extract the slope
- Determination of the rise time for each event by dividing the maximum amplitude by the slope – mean of the distribution defines rise time



Time Resolution: Analysis

- Noise level: Determined in a time span in the recorded waveform before the pulse
- Jitter: Sigma of a Gauss fit to the distribution of noise divided by slope
- Time Spread: Sigma of a Gauss fit to the distribution of the time difference between the two signals
- Time resolution can then be calculated

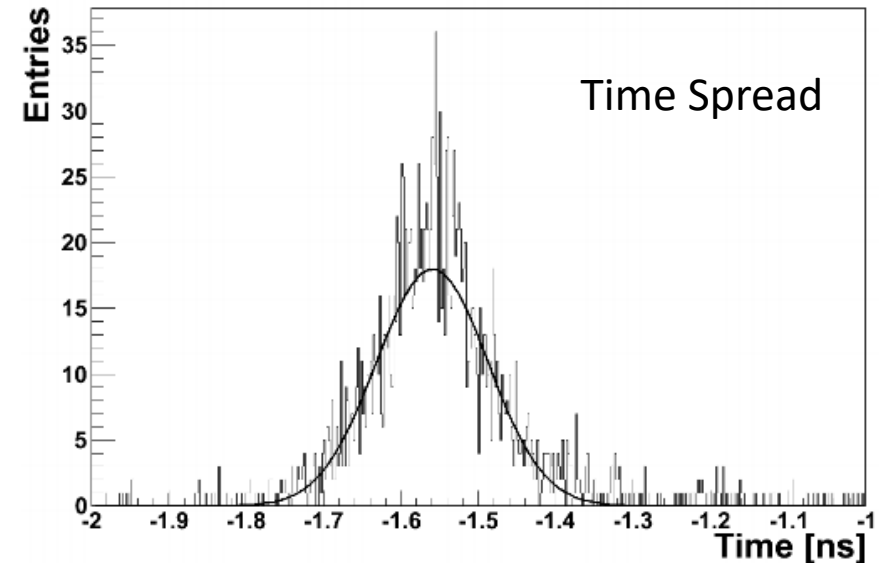
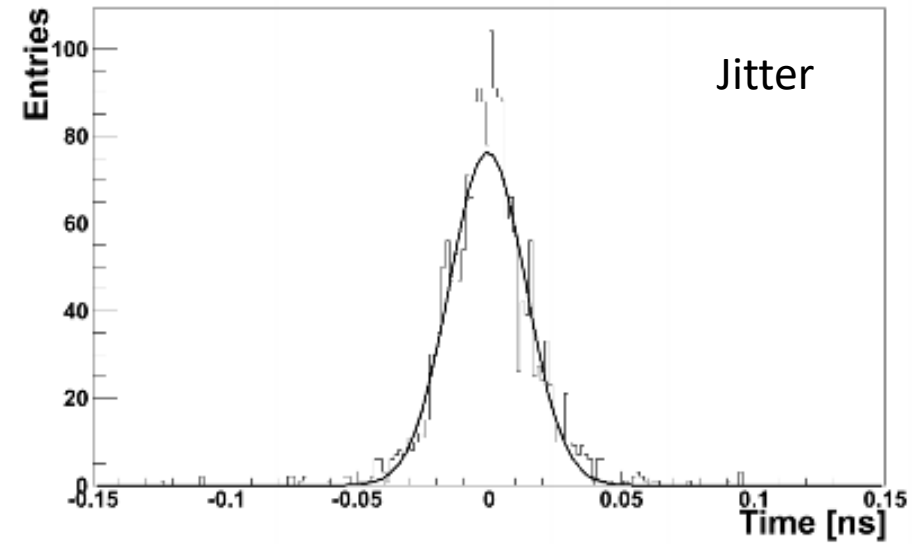
Beta Set-Up:

$$\sigma_{DUT} = \sqrt{\sigma_{TS}^2 - \sigma_{Ref}^2}$$

$$\sigma_{Ref} = 25.18 \pm 0.35 \text{ ps}$$

TCT Set-Up:

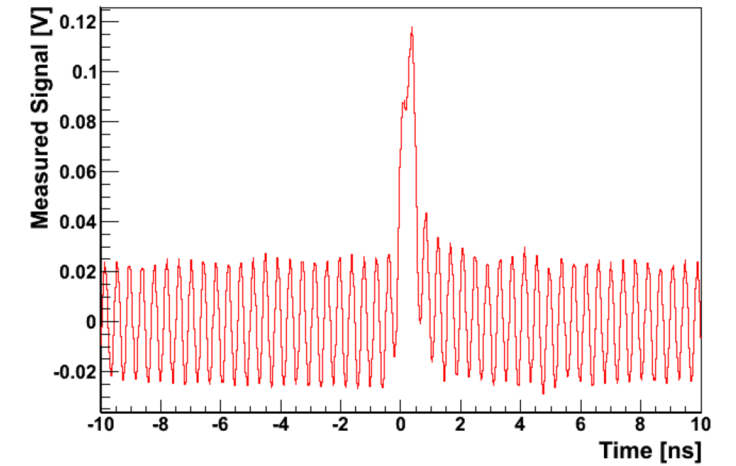
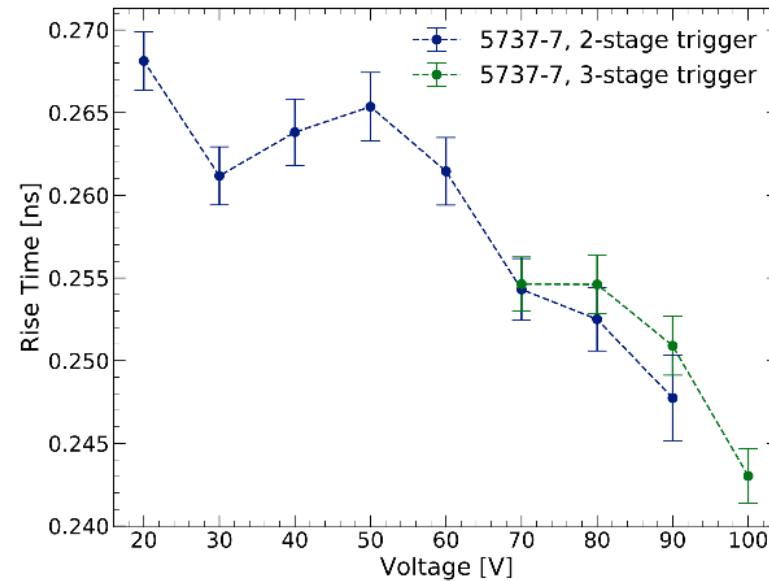
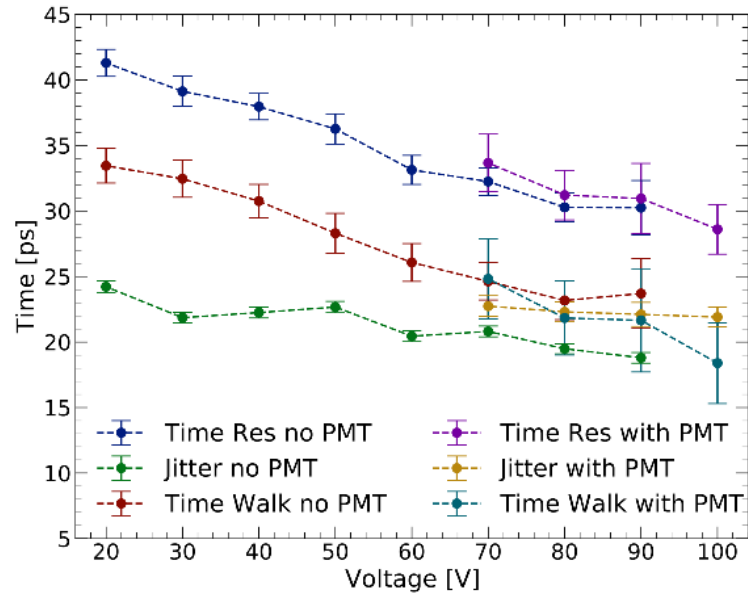
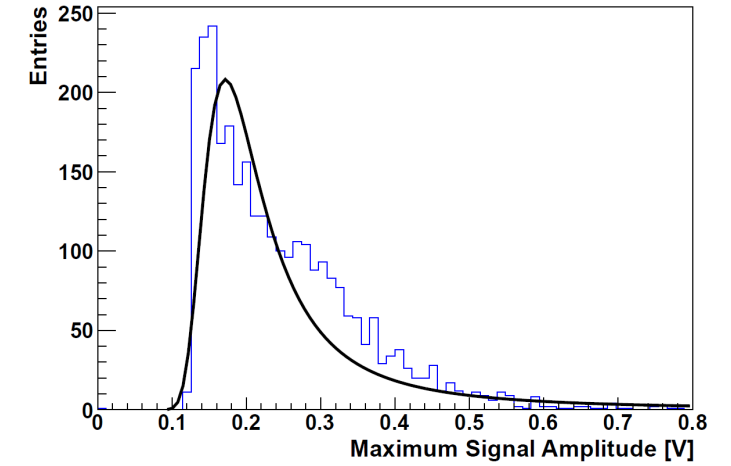
$$\sigma_{DUT} = \frac{\sigma_{TS}}{\sqrt{2}}$$



Time Resolution: 3D Pixel sensors

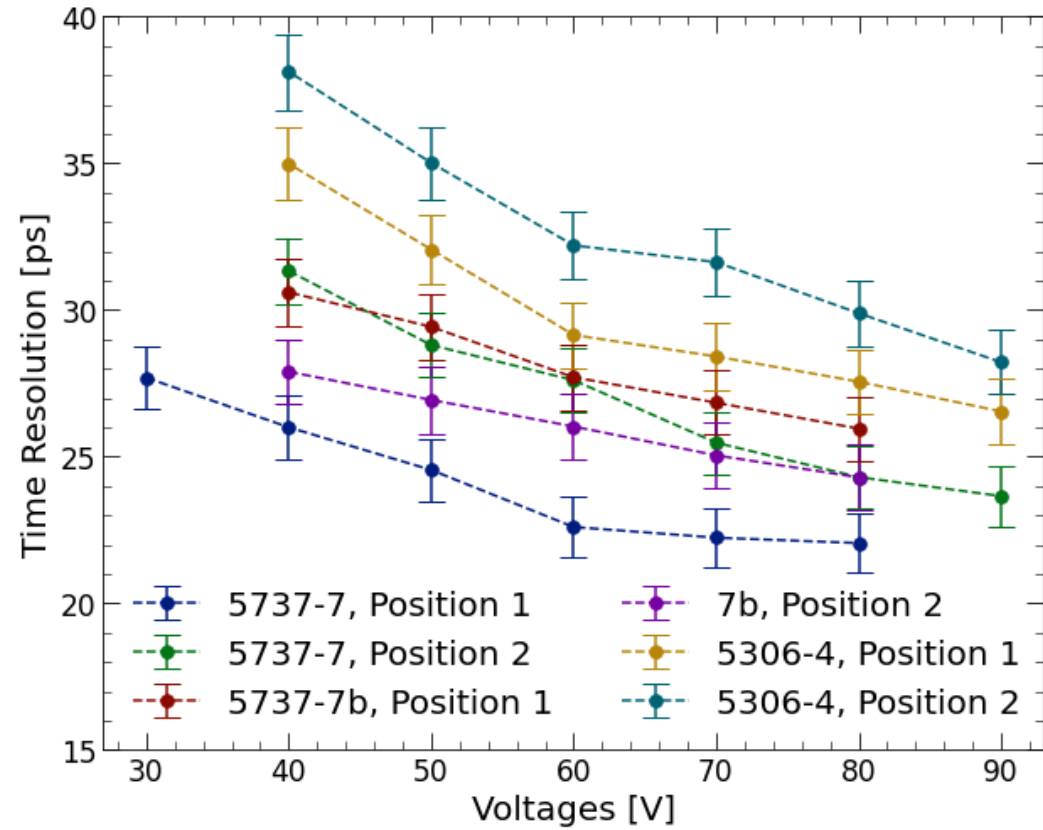
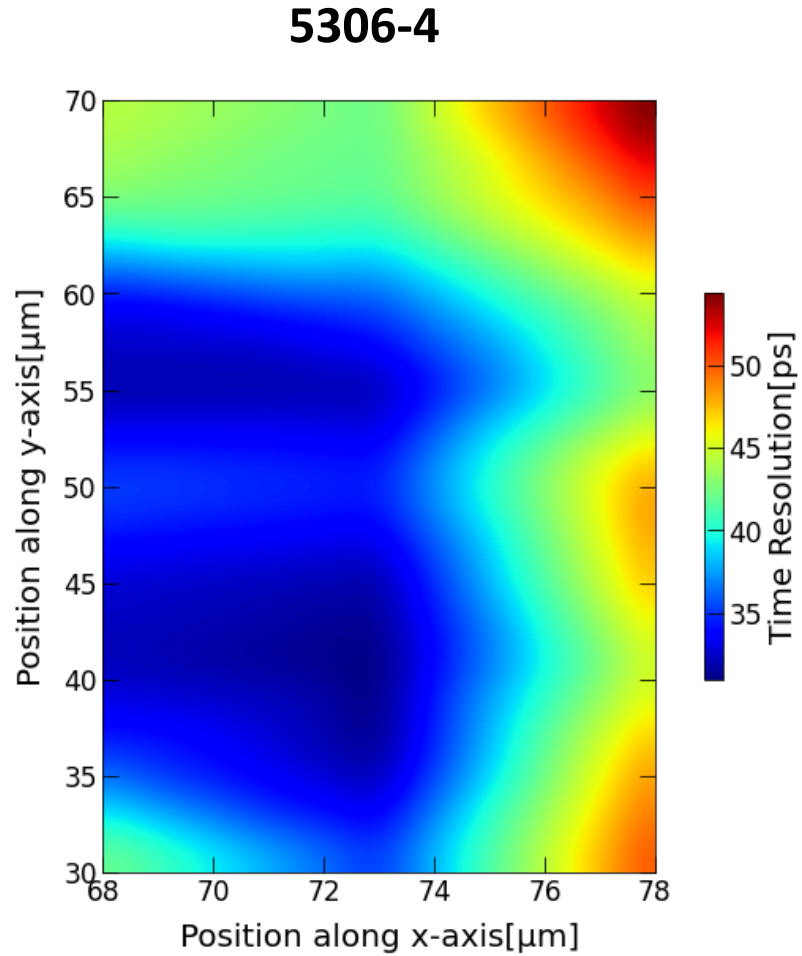
- Sanity Check: Comparison with/without additional PMT trigger
- With PMT: Very low rate – pick-up noise problems
- Without PMT: overestimation of MPV
- Otherwise: Very comparable results

➤ All further measurements without PMT – improved statistics and measurement time, while time resolution characteristics are maintained



Average waveform with PMT trigger

3D Pixel sensors



Expected voltage dependence